# Intel<sup>®</sup> Advanced Boot Block Flash Memory (B3)

28F008/800B3, 28F016/160B3, 28F320B3, 28F640B3

### **Datasheet**

# **Product Features**

- Flexible SmartVoltage Technology —2.7 V – 3.6 V read/program/erase
- $-12 \text{ V V}_{PP}$  fast production programming
- 1.65 V .5 V or 2.7 V 3.6 V I/O option
   —Reduces overall system power
- High Performance
- -2.7 V 3.6 V: 70 ns max access time
- Optimized Block Sizes
   —Eight 8-KB blocks for data, top or bottom locations
- —Up to 127 x 64-KB blocks for code
- Block Locking

   V<sub>CC</sub>-level control through Write Protect WP#
- Low Power Consumption
   —9 mA typical read current
- Absolute Hardware-Protection
- $-V_{PP} = GND$  option
- -V<sub>CC</sub> lockout voltage
- Extended Temperature Operation
- —–40 °C to +85 °C
- Automated Program and Block Erase —Status registers

- Intel<sup>®</sup> Flash Data Integrator Software
- -Flash Memory Manager
- -System Interrupt Manager
- ---Supports parameter storage, streaming data (for example, voice)
- Extended Cycling Capability
   —Minimum 100,000 block erase cycles
- Automatic Power Savings Feature
- -Typical I<sub>CCS</sub> after bus inactivity
- Standard Surface Mount Packaging —48-Ball CSP packages
- -40-Lead and 48-Lead TSOP packages
- Density and Footprint Upgradeable for common package
- ETOX<sup>TM</sup> VIII (0.13 μm) Flash Technology
- -16-Mbit and 32-Mbit densities
- ETOX<sup>TM</sup> VII (0.18 μm) Flash Technology —16-, 32-, and 64-Mbit densities
- ETOX <sup>TM</sup> VI (0.25μm) Flash Technology —8-, 16-, and 32-Mbit densities
- Bo not use the x8 option for new designs

The Intel<sup>®</sup> Advanced Boot Block Flash Memory (B3) device, manufactured on the Intel 0.13  $\mu$ m and 0.18  $\mu$ m technologies, is a feature-rich solution at a low system cost. The B3 device in x16 is available in 48-lead TSOP and 48-ball CSP packages. The x8 option of this product family is available only in 40-lead TSOP and 48-ball  $\mu$ BGA\* packages. For additional information about this product family, see the Intel website: http://www.intel.com/design/flash.

**Notice:** This specification is subject to change without notice. Verify with your local Intel sales office that you have the latest datasheet before finalizing a design.

INFORMATION IN THIS DOCUMENT IS PROVIDED IN CONNECTION WITH INTEL® PRODUCTS. NO LICENSE, EXPRESS OR IMPLIED, BY ESTOPPEL OR OTHERWISE, TO ANY INTELLECTUAL PROPERTY RIGHTS IS GRANTED BY THIS DOCUMENT. EXCEPT AS PROVIDED IN INTEL'S TERMS AND CONDITIONS OF SALE FOR SUCH PRODUCTS, INTEL ASSUMES NO LIABILITY WHATSOEVER, AND INTEL DISCLAIMS ANY EXPRESS OR IMPLIED WARRANTY, RELATING TO SALE AND/OR USE OF INTEL PRODUCTS INCLUDING LIABILITY OR WARRANTIES RELATING TO FITNESS FOR A PARTICULAR PURPOSE, MERCHANTABILITY, OR INFRINGEMENT OF ANY PATENT, COPYRIGHT OR OTHER INTELLECTUAL PROPERTY RIGHT.

Intel products are not intended for use in medical, life saving, life sustaining, critical control or safety systems, or in nuclear facility applications.

Intel may make changes to specifications and product descriptions at any time, without notice.

The Intel® Advanced Boot Block Flash Memory (B3) may contain design defects or errors known as errata which may cause the product to deviate from published specifications. Current characterized errata are available on request.

Contact your local Intel sales office or your distributor to obtain the latest specifications and before placing your product order.

Copies of documents which have an ordering number and are referenced in this document, or other Intel literature may be obtained by calling 1-800 548-4725 or by visiting Intel's website at http://www.intel.com.

Intel, the Intel logo, and ETOX are trademarks or registered trademarks of Intel Corporation or its subsidiaries in the United States and other countries.

\*Other names and brands may be claimed as the property of others.

Copyright © 2005, Intel Corporation.

18 Aug 2005 2 Intel<sup>®</sup> Advanced Boot Block Flash Memory (B3) Order Number: 290580, Revision: 020



28F008/800B3, 28F016/160B3, 28F320B3, 28F640B3

# intel 28F004 Contents

| 1.0 Introduction |                                 |  |                |  |  |
|------------------|---------------------------------|--|----------------|--|--|
|                  | 1.1                             | Nomenclature   |                |  |  |
| • •              | 1.2                             |  |                |  |  |
| 2.0              |                                 | ctional Overview   |                |  |  |
| 3.0              | Fund                            | ctional Overview   | 9              |  |  |
|                  | 3.1<br>3.2                      | Architecture Diagram<br>Memory Maps and Block Organization<br>3.2.1 Parameter Blocks<br>3.2.2 Main Blocks  | 11<br>11       |  |  |
|                  |                                 | <ul> <li>3.2.3 4-Mbit, 8-Mbit, 16-Mbit, 32-Mbit, and 64-Mbit Word-Wide Memory Maps</li> <li>3.2.4 4-Mbit, 8-Mbit, and 16-Mbit Byte-Wide Memory Maps</li> </ul>   | 11             |  |  |
| 4.0              | Pacl                            | kage Information   | 24             |  |  |
|                  | 4.1<br>4.2<br>4.3               | mBGA* and Very Thin Profile Fine Pitch Ball Grid Array (VF BGA) Package<br>TSOP Package<br>Easy BGA Package  | 25             |  |  |
| 5.0              |                                 | but and Signal Descriptions  |                |  |  |
| 0.0              | 5.1                             | Signal Pinouts   | 27             |  |  |
|                  | 5.2                             | Signal Descriptions  |                |  |  |
| 6.0              | Max                             | imum Ratings and Operating Conditions  | 32             |  |  |
|                  | 6.1<br>6.2                      | Absolute Maximum Ratings<br>Operating Conditions   |                |  |  |
| 7.0              | Elec                            | trical Specifications  | 34             |  |  |
|                  | 7.1<br>7.2                      | DC Current Characteristics<br>DC Voltage Characteristics   |                |  |  |
| 8.0              | AC (                            | Characteristics  | 37             |  |  |
|                  | 8.1<br>8.2<br>8.3<br>8.4<br>8.5 | AC Read Characteristics<br>AC Write Characteristics<br>Erase and Program Timing<br>AC I/O Test Conditions<br>Device Capacitance  | 41<br>45<br>46 |  |  |
| 9.0              | Pow                             | er and Reset Specifications  | 47             |  |  |
|                  | 9.1<br>9.2<br>9.3               | Power-Up/Down Characteristics         9.1.1       RP# Connected to System Reset         9.1.2       V <sub>CC</sub> , V <sub>PP</sub> , and RP# Transitions         Reset Specifications         Power Supply Decoupling | 47<br>47<br>48 |  |  |
|                  |                                 |  |                |  |  |



|            | 9.4             | Power Consumption                          | 49 |
|------------|-----------------|--|----|
|            |                 | 9.4.1 Active Power                         |    |
|            |                 | 9.4.2 Automatic Power Savings (APS)        |    |
|            |                 | 9.4.3 Standby Power                        |    |
|            |                 | 9.4.4 Deep Power-Down Mode                 | 50 |
| 10.0       | Оре             | rations Overview                           | 50 |
|            | 10.1            | Bus Operations                             | 51 |
|            |                 | 10.1.1 Read                                | 51 |
|            |                 | 10.1.2 Output Disable                      | 52 |
|            |                 | 10.1.3 Standby                             |    |
|            |                 | 10.1.4 Deep Power-Down / Reset             |    |
|            |                 | 10.1.5 Write                               | 53 |
| 11.0       | Ореі            | rating Modes                               | 53 |
|            | 11.1            | Read Array                                 | 54 |
|            | 11.2            | Read Identifier                            | 56 |
|            | 11.3            | Read Status Register                       | 56 |
|            |                 | 11.3.1 Clearing the Status Register        | 57 |
|            | 11.4            | Program Mode                               |    |
|            |                 | 11.4.1 Suspending and Resuming Programming |    |
|            | 11.5            | Erase Mode                                 |    |
|            |                 | 11.5.1 Suspending and Resuming Erase       | 59 |
| 12.0       | Bloc            | k Locking                                  | 62 |
|            | 12.1            | WP# = V <sub>IL</sub> for Block Locking    | 62 |
|            | 12.2            | $WP# = V_{IH}$ for Block Unlocking         |    |
| 13.0       | V <sub>PP</sub> | Program and Erase Voltages                 | 63 |
|            |                 | $V_{PP} = V_{IL}$ for Complete Protection  |    |
| 14.0       | Addi            | itional Information                        | 63 |
| Арр        | endix           | A Write State Machine Current/Next States  | 64 |
| Арр        | endix           | B Program and Erase Flowcharts             | 66 |
| ۰.<br>۸ nn | endix           | -  |    |
| whh        | GIUIX           |  | 10 |



# **Revision History**

| Revision<br>Number | Description   |
|--------------------|---|
| -001               | Original version  |
| -002               | Section 3.4, <i>V<sub>PP</sub> Program and Erase Voltages</i> , added<br>Updated Figure 9: <i>Automated Block Erase Flowchart</i><br>Updated Figure 10: <i>Erase Suspend/Resume Flowchart</i> (added program to table)<br>Updated Figure 16: <i>AC Waveform: Program and Erase Operations</i> (updated notes)<br>I <sub>PPR</sub> maximum specification change from ±25 μA to ±50 μA<br>Program and Erase Suspend Latency specification change<br>Updated Appendix A: <i>Ordering Information</i> (included 8 M and 4 M information)<br>Updated Figure, Appendix D: <i>Architecture Block Diagram</i> (Block info. in words not bytes)<br>Minor wording changes   |
| -003               | Combined byte-wide specification (previously 290605) with this document<br>Improved speed specification to 80 ns (3.0 V) and 90 ns (2.7 V)<br>Improved 1.8 V I/O option to minimum 1.65 V (Section 3.4)<br>Improved several DC characteristics (Section 4.4)<br>Improved several AC characteristics (Section 4.5 and 4.6)<br>Combined 2.7 V and 1.8 V DC characteristics (Section 4.4)<br>Added 5 V V <sub>PP</sub> read specification (Section 3.4)<br>Removed 120 ns and 150 ns speed offerings<br>Moved Ordering Information from Appendix to Section 6.0; updated information<br>Moved Additional Information from Appendix to Section 7.0<br>Updated figure Appendix B, Access Time vs. Capacitive Load<br>Updated figure Appendix C, Architecture Block Diagram<br>Moved Program and Erase Flowcharts to Appendix E<br>Updated Program Flowchart<br>Updated Program Suspend/Resume Flowchart<br>Minor text edits throughout   |
| -004               | Added 32-Mbit density<br>Added 98H as a reserved command (Table 4)<br>$A_1-A_{20} = 0$ when in read identifier mode (Section 3.2.2)<br>Status register clarification for SR3 (Table 7)<br>$V_{CC}$ and $V_{CCQ}$ absolute maximum specification = 3.7 V (Section 4.1)<br>Combined I <sub>PPW</sub> and I <sub>CCW</sub> into one specification (Section 4.4)<br>Combined I <sub>PPE</sub> and I <sub>CCE</sub> into one specification (Section 4.4)<br>Max Parameter Block Erase Time (t <sub>WHQV2</sub> /t <sub>EHQV2</sub> ) reduced to 4 sec (Section 4.7)<br>Max Main Block Erase Time (t <sub>WHQV3</sub> /t <sub>EHQV3</sub> ) reduced to 5 sec (Section 4.7)<br>Erase suspend time @ 12 V (t <sub>WHRH2</sub> /t <sub>EHRH2</sub> ) changed to 5 µs typical and 20 µs maximum<br>(Section 4.7)<br><i>Ordering Information</i> updated (Section 6.0)<br>Write State Machine Current/Next States Table updated (Appendix A)<br>Program Suspend/Resume Flowchart updated (Appendix F)<br>Erase Suspend/Resume Flowchart updated (Appendix F)<br>Text clarifications throughout |
| -005               | $\begin{array}{l} \mu BGA \mbox{ package diagrams corrected (Figures 3 and 4)} \\ I_{PPD} \mbox{ test conditions corrected (Section 4.4)} \\ 32-Mbit \mbox{ ordering information corrected (Section 6)} \\ \mu BGA \mbox{ package top side mark information added (Section 6)} \end{array}$   |
| -006               | V <sub>IH</sub> and V <sub>IL</sub> Specification change (Section 4.4)<br>I <sub>CCS</sub> test conditions clarification (Section 4.4)<br>Added Command Sequence Error Note (Table 7)<br>Data sheet renamed from <i>Smart 3 Advanced Boot Block 4-Mbit, 8-Mbit, 16-Mbit Flash</i><br><i>Memory Family.</i><br>Added device ID information for 4-Mbit x8 device<br>Removed 32-Mbit x8 to reflect product offerings<br>Minor text changes   |

#### 28F008/800B3, 28F016/160B3, 28F320B3, 28F640B3

| Revision<br>Number | Description   |
|--------------------|---|
| -007               | Corrected RP# pin description in Table 2, 3 Volt Advanced Boot Block Pin Descriptions<br>Corrected typographical error fixed in Ordering Information  |
| -008               | 4-Mbit packaging and addressing information corrected throughout document   |
| -009               | Corrected 4-Mbit memory addressing tables in Appendices D and E   |
| -010               | Max $I_{CCD}$ changed to 25 $\mu A$ $V_{CC}Max$ on 32 M (28F320B3) changed to 3.3 V   |
| -011               | Added 64-Mbit density and faster speed offerings<br>Removed access time vs. capacitance load curve  |
| -012               | Changed references of 32Mbit 80ns devices to 70ns devices to reflect the faster product offering.<br>Changed VccMax=3.3V reference to indicate the affected product is the 0.25µm 32Mbit device.<br>Minor text edits throughout document. |
| -013               | Added New Pin-1 indicator information on 40 and 48Lead TSOP packages.<br>Minor text edits throughout document.  |
| -014               | Added specifications for 0.13 micron product offerings throughout document  |
| -015               | Minor text edits throughout document.   |
| -016               | Adjusted ordering information.<br>Adjusted specifications for 0.13 micron product offerings.<br>Revised and corrected DC Characteristics Table.<br>Adjusted package diagram information.<br>Minor text edits throughout document.         |
| -017               | Updated ordering information.<br>Adjusted specifications for 0.13 micron product offerings.<br>Updated AC/DC Characteristics Table.<br>Added TSOP and µBGA* package diagram information.<br>Minor text edits throughout document.         |
| -018               | Updated the layout of the datasheet.  |
| -019               | Added line items to Table 34 "Ordering Information: Valid Combinations" on page 70.   |
| -020               | Removed all x8 products from ordering information, page 70  |

intel®

# 1.0 Introduction

intel

This datasheet describes the specifications for the Intel<sup>®</sup> Advanced Boot Block Flash Memory (B3) device (hereafter referred to as the B3 flash memory device).

The B3 flash memory device is optimized for portable, low-power, systems. This family of products features 1.65 V to 2.5 V or 2.7 V to 3.6 V I/Os, and a low  $V_{CC}/V_{PP}$  operating range of 2.7 V to 3.6 V for Read, Program, and Erase operations. The B3 device is also capable of fast programming at 12 V.

Throughout this document:

- 2.7 V refers to the full voltage range 2.7 V to 3.6 V (except where noted otherwise).
- $V_{PP} = 12 \text{ V}$  refers to  $12 \text{ V} \pm 5\%$ .

### 1.1 Nomenclature

#### Table 1.Nomenclature

| Term        | Definition               |
|-------------|--------------------------|
| 0x          | Hexadecimal prefix       |
| 0b          | Binary prefix            |
| Byte        | 8 bits                   |
| Word        | 16 bits                  |
| KW or Kword | 1024 words               |
| Mword       | 1,048,576 words          |
| Kb          | 1024 bits                |
| КВ          | 1024 bytes               |
| Mb          | 1,048,576 bits           |
| MB          | 1,048,576 bytes          |
| APS         | Automatic Power Savings  |
| CSP         | Chip Scale Package       |
| CUI         | Command User Interface   |
| OTP         | One Time Programmable    |
| PR          | Protection Register      |
| PRD         | Protection Register Data |
| PLR         | Protection Lock Register |
| RFU         | Reserved for Future Use  |
| SR          | Status Register          |
| SRD         | Status Register Data     |
| WSM         | Write State Machine      |

### 1.2 Conventions

#### Table 2.Conventions

| Convention                | Description  |  |  |  |  |  |
|---------------------------|--|--|--|--|--|--|
| Pin or signal             | Used interchangeably to refer to the external signal connections on the package.<br><b>Note:</b> For a chip scale package (CSP), the term <i>ball</i> is used in place of <i>pin</i> . |  |  |  |  |  |
| Group Membership Brackets | Square brackets designate group membership or define a group of signals with similar function (for example, A[21:1], SR[4:1])  |  |  |  |  |  |
| Set                       | When referring to registers, the term set means the bit is a logical 1.  |  |  |  |  |  |
| Clear:                    | When referring to registers, the term <i>clear</i> means the bit is a logical 0.   |  |  |  |  |  |
| Block                     | A group of bits (or words) that erase simultaneously using one block erase instruction.  |  |  |  |  |  |
| Main Block                | A block that contains 32 Kwords.   |  |  |  |  |  |
| Parameter Block           | A block that contains 4 Kwords.  |  |  |  |  |  |

# 2.0 Functional Overview

The B3 flash memory device features the following:

- Enhanced blocking for easy segmentation of code and data or additional design flexibility.
- Program Suspend to Read command.
- $V_{CCQ}$  input of 1.65 V to 2.5 V or 2.7 V to 3.6 V on all I/Os. See Figure 1 through Figure 4 for pinout diagrams and  $V_{CCQ}$  location.
- Maximum program and erase time specification for improved data storage.

#### Table 3.B3 Device Feature Summary (Sheet 1 of 2)

| Feature                               | 28F008B3, 28F016B3                                 | 28F800B3, 28F160B3,<br>28F320B3 <sup>(3)</sup> , 28F640B3   | Reference   |
|---------------------------------------|--|---|-------------|
| V <sub>CC</sub> Read Voltage          | 2.7 V-   | Section 6.2, Section 7.2  |             |
| V <sub>CCQ</sub> I/O Voltage          | 1.65 V–2.5 V o                                     | Section 4.2, 4.4  |             |
| V <sub>PP</sub> Program/Erase Voltage | 2.7 V- 3.6 V or                                    | Section 4.2, 4.4  |             |
| Bus Width                             | 8 bit  | 16 bit  | Table 27    |
| Speed                                 | 70 ns, 80 ns, 90 r                                 | Section 8.1   |             |
| Memory Arrangement                    | 1024 Kbit x 8 (8 Mbit),<br>2048 Kbit x 8 (16 Mbit) | 512 Kbit x 16 (8 Mbit),<br>1024 Kbit x 16 (16 Mbit),<br>2048 Kbit x 16 (32 Mbit),<br>4096 Kbit x 16 (64 Mbit) | Section 3.2 |



#### Table 3. B3 Device Feature Summary (Sheet 2 of 2)

| Feature                  | 28F008B3, 28F016B3         28F800B3, 28F160B3, 28F160B3, 28F320B3 <sup>(3)</sup> , 28F640B3                          |   | Reference                |  |
|--------------------------|--|---|--------------------------|--|
| Blocking (top or bottom) | Eight 8-Kbyte para<br>Fifteen 64-Kbyte<br>Thirty-one 64-Kbyte<br>Sixty-three 64-Kbyte<br>One hundred twenty-seven 64 | Section 3.2, "Memory<br>Maps and Block<br>Organization" on<br>page 11 |                          |  |
| Locking                  | cking WP# locks/unlocks parameter blocks<br>All other blocks protected using V <sub>PP</sub>                         |   |                          |  |
| Operating Temperature    | Extended: -40  | Section 6.2, Section 7.2  |                          |  |
| Program/Erase Cycling    | 100,000 cycles   |   | Section 6.2, Section 7.2 |  |
| Packages                 | 40-lead TSOP <sup>(1)</sup> ,<br>48-Ball μBGA* CSP <sup>(2)</sup>  | 48-Lead TSOP,<br>48-Ball μBGA CSP <sup>(2)</sup> ,<br>48-Ball VF BGA  | Figure 8, Figure 9       |  |

Notes:

1.

32-Mbit and 64-Mbit densities not available in 40-lead TSOP.

2. 8-Mbit densities not available in  $\mu$ BGA\* CSP.

3. V<sub>CC</sub>Max is 3.3 V on 0.25µm 32-Mbit devices.

# 3.0 Functional Overview

Intel provides the most flexible voltage solution in the flash industry, providing three discrete voltage supply pins:

- V<sub>CC</sub> for Read operation
- V<sub>CCO</sub> for output swing
- V<sub>PP</sub> for Program and Erase operation.

All B3 flash memory devices provide program/erase capability at 2.7 V or 12 V (for fast production programming), and read with  $V_{CC}$  at 2.7 V. Because many designs read from the flash memory a large percentage of the time, 2.7 V  $V_{CC}$  operation can provide substantial power savings.

The B3 flash memory device family is available in either x8 or x16 packages in the following densities (see Appendix C, "Ordering Information," for availability):

- 8-Mbit (8, 388, 608-bit) flash memory organized as 512 Kwords of 16 bits each or 1024 Kbytes of 8-bits each.
- 16-Mbit (16, 777, 216-bit) flash memory organized as 1024 Kwords of 16 bits each or 2048 Kbytes of 8-bits each.
- 32-Mbit (33, 554, 432-bit) flash memory organized as 2048 Kwords of 16 bits each.
- 64-Mbit (67, 108, 864-bit) flash memory organized as 4096 Kwords of 16 bits each.

The parameter blocks are located at either the top (denoted by -T suffix) or the bottom (-B suffix) of the address map, to accommodate different microprocessor protocols for kernel code location. The upper two (or lower two) parameter blocks can be locked to provide complete code security for system initialization code. Locking and unlocking is controlled by Write Protect WP# (see Section 12.0, "Block Locking" on page 62 for details).

Datasheet

Intel<sup>®</sup> Advanced Boot Block Flash Memory (B3) Order Number: 290580, Revision: 020



- The Command User Interface (CUI) is the interface between the microprocessor or microcontroller and the internal operation of the flash memory.
- The internal Write State Machine (WSM) automatically executes the algorithms and timings necessary for Program and Erase operations (including verification), which unburdens the microprocessor or microcontroller.
- To indicate the status of the WSM, the Status Register signifies block erase or word program completion and status.

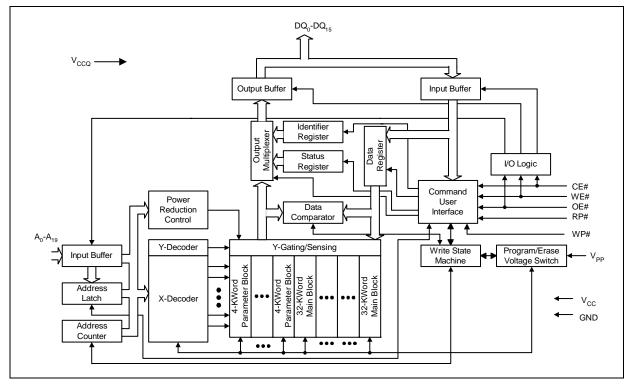
The B3 flash memory device also provides Automatic Power Savings (APS), which minimizes system current drain and allows for very low power designs. This mode is entered following the completion of a read cycle (approximately 300 ns later).

The RP# pin provides additional protection against unwanted command writes that might occur during system reset and power-up/down sequences due to invalid system bus conditions (see "Power and Reset Specifications" on page 47).

- Section 10.0, "Operations Overview" on page 50 explains the different modes of operation.
- Section 7.0, "Electrical Specifications" on page 34 and Section 8.0, "AC Characteristics" on page 37 provide complete current and voltage specifications.
- Section 8.1, "AC Read Characteristics" on page 37 provides read, program, and erase performance specifications.

### 3.1 Architecture Diagram

#### Figure 1. B3 Architecture Block Diagram



# 3.2 Memory Maps and Block Organization

The B3 flash memory device uses an asymmetrically blocked architecture, enabling system integration of code and data within a single flash memory device. Each block can be erased independently of other blocks up to 100,000 times. For the address locations of each block, see the following memory maps:

- Table 4 "16-Mbit and 32-Mbit Word-Wide Memory Addressing Map" on page 11
- Table 5 "4-Mbit and 8-Mbit Word-Wide Memory Addressing Map" on page 14
- Table 6 "16-Mbit, 32-Mbit, and 64-Mbit Word-Wide Memory Addressing Map" on page 15
- Table 7 "8-Mbit and 16-Mbit Byte-Wide Memory Addressing Map" on page 20
- Table 8 "4-Mbit Byte Wide Memory Addressing Map" on page 23

#### 3.2.1 Parameter Blocks

The B3 flash memory device architecture includes parameter blocks to facilitate storing frequently updated small parameters (such as data traditionally stored in an EEPROM). The word-rewrite functionality of EEPROMs can be emulated using software techniques. Each flash memory device contains eight parameter blocks of 8 Kbytes/4 Kwords (8192 bytes/4,096 words) each.

### 3.2.2 Main Blocks

After the parameter blocks, the remainder of the flash memory array is divided into equal-size main blocks (65,536 bytes/32,768 words) for data or code storage.

- The 8-Mbit flash memory device contains 15 main blocks.
- The 16-Mbit flash memory device contains 31 main blocks.
- The 32-Mbit memory device contains 63 main blocks.
- The 64-Mbit memory device contains 127 main blocks.

#### 3.2.3 4-Mbit, 8-Mbit, 16-Mbit, 32-Mbit, and 64-Mbit Word-Wide Memory Maps

#### Table 4. 16-Mbit and 32-Mbit Word-Wide Memory Addressing Map (Sheet 1 of 4)

#### 16-Mbit and 32-Mbit Word-Wide Memory Addressing

| Top Boot     |  |             |               |              | В      | ottom Boot |                   |
|--------------|--|-------------|---------------|--------------|--------|------------|-------------------|
| Size<br>(KW) |  | 16 Mbit     | 32 Mbit       | Size<br>(KW) | 8 Mbit | 16 Mbit    | 32 Mbit           |
| 4            |  | FF000-FFFFF | 1FF000-1FFFFF | 32           |        |            | 1F8000-1FFFFF     |
| 4            |  | FE000-FEFFF | 1FE000-1FEFFF | 32           |        |            | 1F0000-1F7FFF     |
| 4            |  | FD000-FDFFF | 1FD000-1FDFFF | 32           |        |            | 1E8000-<br>1EFFFF |
| 4            |  | FC000-FCFFF | 1FC000-1FCFFF | 32           |        |            | 1E0000-<br>1E7FFF |



#### Table 4. 16-Mbit and 32-Mbit Word-Wide Memory Addressing Map (Sheet 2 of 4)

|              | Top Boot    |               |              | E      | Bottom Boot |                   |
|--------------|-------------|---------------|--------------|--------|-------------|-------------------|
| Size<br>(KW) | 16 Mbit     | 32 Mbit       | Size<br>(KW) | 8 Mbit | 16 Mbit     | 32 Mbit           |
| 4            | FB000-FBFFF | 1FB000-1FBFFF | 32           |        |             | 1D8000-<br>1DFFFF |
| 4            | FA000-FAFFF | 1FA000-1FAFFF | 32           |        |             | 1D0000-<br>1D7FFF |
| 4            | F9000-F9FFF | 1F9000-1F9FFF | 32           |        |             | 1C8000-<br>1CFFFF |
| 4            | F8000-F8FFF | 1F8000-1F8FFF | 32           |        |             | 1C0000-<br>1C7FFF |
| 32           | F0000-F7FFF | 1F0000-1F7FFF | 32           |        |             | 1B8000-<br>1BFFFF |
| 32           | E8000-EFFFF | 1E8000-1EFFFF | 32           |        |             | 1B0000-<br>1B7FFF |
| 32           | E0000-E7FFF | 1E0000-1E7FFF | 32           |        |             | 1A8000-<br>1AFFFF |
| 32           | D8000-DFFFF | 1D8000-1DFFFF | 32           |        |             | 1A0000-<br>1A7FFF |
| 32           | D0000-D7FFF | 1D0000-1D7FFF | 32           |        |             | 198000-19FFFF     |
| 32           | C8000-CFFFF | 1C8000-1CFFFF | 32           |        |             | 190000-197FFF     |
| 32           | C0000-C7FFF | 1C0000-1C7FFF | 32           |        |             | 188000-18FFFF     |
| 32           | B8000-BFFFF | 1B8000-1BFFFF | 32           |        |             | 180000-187FFF     |
| 32           | B0000-B7FFF | 1B0000-1B7FFF | 32           |        |             | 178000-17FFFF     |
| 32           | A8000-AFFFF | 1A8000-1AFFFF | 32           |        |             | 170000-177FFF     |
| 32           | A0000-A7FFF | 1A0000-1A7FFF | 32           |        |             | 168000-16FFFF     |
| 32           | 98000-9FFFF | 198000-19FFFF | 32           |        |             | 160000-167FFF     |
| 32           | 90000-97FFF | 190000-197FFF | 32           |        |             | 158000-15FFFF     |
| 32           | 88000-8FFFF | 188000-18FFFF | 32           |        |             | 150000-157FFF     |
| 32           | 80000-87FFF | 180000-187FFF | 32           |        |             | 148000-14FFFF     |
| 32           | 78000-7FFFF | 178000-17FFFF | 32           |        |             | 140000-147FFF     |
| 32           | 70000-77FFF | 170000-177FFF | 32           |        |             | 138000-13FFFF     |
| 32           | 68000-6FFFF | 168000-16FFFF | 32           |        |             | 130000-137FFF     |
| 32           | 60000-67FFF | 160000-167FFF | 32           |        |             | 128000-12FFFF     |
| 32           | 58000-5FFFF | 158000-15FFFF | 32           |        |             | 120000-127FFF     |
| 32           | 50000-57FFF | 150000-157FFF | 32           |        |             | 118000-11FFFF     |
| 32           | 48000-4FFFF | 148000-14FFFF | 32           |        |             | 110000-117FFF     |
| 32           | 40000-47FFF | 140000-147FFF | 32           |        |             | 108000-10FFFF     |
| 32           | 38000-3FFFF | 138000-13FFFF | 32           |        |             | 100000-107FFF     |
| 32           | 30000-37FFF | 130000-137FFF | 32           |        | F8000-FFFFF | 0F8000-0FFFFF     |
| 32           | 28000-2FFFF | 128000-12FFFF | 32           |        | F0000-F7FFF | 0F0000-0F7FFF     |

#### 16-Mbit and 32-Mbit Word-Wide Memory Addressing

18 Aug 2005 12

#### Table 4.16-Mbit and 32-Mbit Word-Wide Memory Addressing Map (Sheet 3 of 4)

|              | 16-Mbit and 32-Mbit Word-<br>Top Boot |                   |               |              |             | ottom Boot        |                   |
|--------------|---------------------------------------|-------------------|---------------|--------------|-------------|-------------------|-------------------|
|              |                                       |                   |               |              | B           |                   |                   |
| Size<br>(KW) |                                       | 16 Mbit           | 32 Mbit       | Size<br>(KW) | 8 Mbit      | 16 Mbit           | 32 Mbit           |
| 32           |                                       | 20000-27FFF       | 120000-127FFF | 32           |             | E8000-EFFFF       | 0E8000-<br>0EFFFF |
| 32           |                                       | 18000-1FFFF       | 118000-11FFFF | 32           |             | E0000-E7FFF       | 0E0000-<br>0E7FFF |
| 32           |                                       | 10000-17FFF       | 110000-117FFF | 32           |             | D8000-DFFFF       | 0D8000-<br>0DFFFF |
| 32           |                                       | 08000-0FFFF       | 108000-10FFFF | 32           |             | D0000-D7FFF       | 0D0000-<br>0D7FFF |
| 32           |                                       | 00000-07FFF       | 100000-107FFF | 32           |             | C8000-CFFFF       | 0C8000-<br>0CFFFF |
|              | This column                           | continues on next | page          |              | This column | continues on next | page              |
| 32           |                                       |                   | 0F8000-0FFFFF | 32           |             | C0000-C7FFF       | 0C0000-<br>0C7FFF |
| 32           |                                       |                   | 0F0000-0F7FFF | 32           |             | B8000-BFFFF       | 0B8000-<br>0BFFFF |
| 32           |                                       |                   | 0E8000-0EFFFF | 32           |             | B0000-B7FFF       | 0B0000-<br>0B7FFF |
| 32           |                                       |                   | 0E0000-0E7FFF | 32           |             | A8000-AFFFF       | 0A8000-<br>0AFFFF |
| 32           |                                       |                   | 0D8000-0DFFFF | 32           |             | A0000-A7FFF       | 0A0000-<br>0A7FFF |
| 32           |                                       |                   | 0D0000-0D7FFF | 32           |             | 98000-9FFFF       | 098000-09FFFF     |
| 32           |                                       |                   | 0C8000-0CFFFF | 32           |             | 90000-97FFF       | 090000-097FFF     |
| 32           |                                       |                   | 0C0000-0C7FFF | 32           |             | 88000-8FFFF       | 088000-08FFFF     |
| 32           |                                       |                   | 0B8000-0BFFFF | 32           |             | 80000-87FFF       | 080000-087FFF     |
| 32           |                                       |                   | 0B0000-0B7FFF | 32           |             | 78000-7FFFF       | 78000-7FFFF       |
| 32           |                                       |                   | 0A8000-0AFFFF | 32           |             | 70000-77FFF       | 70000-77FFF       |
| 32           |                                       |                   | 0A0000-0A7FFF | 32           |             | 68000-6FFFF       | 68000-6FFFF       |
| 32           |                                       |                   | 098000-09FFFF | 32           |             | 60000-67FFF       | 60000-67FFF       |
| 32           |                                       |                   | 090000-097FFF | 32           |             | 58000-5FFFF       | 58000-5FFFF       |
| 32           |                                       |                   | 088000-08FFFF | 32           |             | 50000-57FFF       | 50000-57FFF       |
| 32           |                                       |                   | 080000-087FFF | 32           |             | 48000-4FFFF       | 48000-4FFFF       |
| 32           |                                       |                   | 078000-07FFFF | 32           |             | 40000-47FFF       | 40000-47FFF       |
| 32           |                                       |                   | 070000-077FFF | 32           |             | 38000-3FFFF       | 38000-3FFFF       |
| 32           |                                       |                   | 068000-06FFFF | 32           |             | 30000-37FFF       | 30000-37FFF       |
| 32           |                                       |                   | 060000-067FFF | 32           |             | 28000-2FFFF       | 28000-2FFFF       |
| 32           |                                       |                   | 058000-05FFFF | 32           |             | 20000-27FFF       | 20000-27FFF       |
| 32           |                                       |                   | 050000-057FFF | 32           |             | 18000-1FFFF       | 18000-1FFFF       |
| 32           |                                       |                   | 048000-04FFFF | 32           |             | 10000-17FFF       | 10000-17FFF       |
| 32           |                                       |                   | 040000-047FFF | 32           |             | 08000-0FFFF       | 08000-0FFFF       |

#### 16-Mbit and 32-Mbit Word-Wide Memory Addressing

#### 28F008/800B3, 28F016/160B3, 28F320B3, 28F640B3



#### 4. 16-Mbit and 32-Mbit Word-Wide Memory Addressing Map (Sheet 4 of 4)

#### 16-Mbit and 32-Mbit Word-Wide Memory Addressing

|        | Top Boot |         |               |              | Bottom Boot |             |             |  |  |
|--------|----------|---------|---------------|--------------|-------------|-------------|-------------|--|--|
| e<br>) |          | 16 Mbit | 32 Mbit       | Size<br>(KW) | 8 Mbit      | 16 Mbit     | 32 Mbit     |  |  |
| _      |          |         | 038000-03FFFF | 4            |             | 07000-07FFF | 07000-07FFF |  |  |
|        |          |         | 030000-037FFF | 4            |             | 06000-06FFF | 06000-06FFF |  |  |
|        |          |         | 028000-02FFFF | 4            |             | 05000-05FFF | 05000-05FFF |  |  |
|        |          |         | 020000-027FFF | 4            |             | 04000-04FFF | 04000-04FFF |  |  |
|        |          |         | 018000-01FFFF | 4            |             | 03000-03FFF | 03000-03FFF |  |  |
|        |          |         | 010000-017FFF | 4            |             | 02000-02FFF | 02000-02FFF |  |  |
|        |          |         | 008000-00FFFF | 4            |             | 01000-01FFF | 01000-01FFF |  |  |
|        |          |         | 000000-007FFF | 4            |             | 00000-00FFF | 00000-00FFF |  |  |

#### Table 5.4-Mbit and 8-Mbit Word-Wide Memory Addressing Map (Sheet 1 of 2)

|              |             | Top Boot    |              | В           | ottom Boot  |  |
|--------------|-------------|-------------|--------------|-------------|-------------|--|
| Size<br>(KW) | 4 Mbit      |             | Size<br>(KW) | 4 Mbit      | 8 Mbit      |  |
|              | 3F000-3FFFF | 7F000-7FFFF | 32           |             | 78000-7FFFF |  |
|              | 3E000-3EFFF | 7E000-7EFFF | 32           |             | 70000-77FFF |  |
|              | 3D000-3DFFF | 7D000-7DFFF | 32           |             | 68000-6FFFF |  |
|              | 3C000-3CFFF | 7C000-7CFFF | 32           |             | 60000-67FFF |  |
|              | 3B000-3BFFF | 7B000-7BFFF | 32           |             | 58000-5FFFF |  |
|              | 3A000-3AFFF | 7A000-7AFFF | 32           |             | 50000-57FFF |  |
|              | 39000-39FFF | 79000-79FFF | 32           |             | 48000-4FFFF |  |
|              | 38000-38FFF | 78000-78FFF | 32           |             | 40000-47FFF |  |
| 4            | 30000-37FFF | 70000-77FFF | 32           | 38000-3FFFF | 38000-3FFFF |  |
| 4            | 28000-2FFFF | 68000-6FFFF | 32           | 30000-37FFF | 30000-37FFF |  |
| 4            | 20000-27FFF | 60000-67FFF | 32           | 28000-2FFFF | 28000-2FFFF |  |
| 4            | 18000-1FFFF | 58000-5FFFF | 32           | 20000-27FFF | 20000-27FFF |  |
| 4            | 10000-17FFF | 50000-57FFF | 32           | 18000-1FFFF | 18000-1FFFF |  |
| 4            | 08000-0FFFF | 48000-4FFFF | 32           | 10000-17FFF | 10000-17FFF |  |
| 4            | 00000-07FFF | 40000-47FFF | 32           | 08000-0FFFF | 08000-0FFFF |  |
| 4            |             | 38000-3FFFF | 4            | 07000-07FFF | 07000-07FFF |  |
| 32           |             | 30000-37FFF | 4            | 06000-06FFF | 06000-06FFF |  |
| 32           |             | 28000-2FFFF | 4            | 05000-05FFF | 05000-05FFF |  |
| 32           |             | 20000-27FFF | 4            | 04000-04FFF | 04000-04FFF |  |
| 32           |             | 18000-1FFFF | 4            | 03000-03FFF | 03000-03FFF |  |

#### 4-Mbit and 8-Mbit Word-Wide Memory Addressing



#### Table 5. 4-Mbit and 8-Mbit Word-Wide Memory Addressing Map (Sheet 2 of 2)

#### 4-Mbit and 8-Mbit Word-Wide Memory Addressing

|              | Top Boot |             |  | Bottom Boot  |             |             |  |
|--------------|----------|-------------|--|--------------|-------------|-------------|--|
| Size<br>(KW) | 4 Mbit   |             |  | Size<br>(KW) | 4 Mbit      | 8 Mbit      |  |
| 32           |          | 10000-17FFF |  | 4            | 02000-02FFF | 02000-02FFF |  |
| 32           |          | 08000-0FFFF |  | 4            | 01000-01FFF | 01000-01FFF |  |
| 32           |          | 00000-07FFF |  | 4            | 00000-00FFF | 00000-00FFF |  |

#### Table 6.16-Mbit, 32-Mbit, and 64-Mbit Word-Wide Memory Addressing Map (Sheet 1 of 6)

#### 16-Mbit, 32-Mbit, and 64-Mbit Word-Wide Memory Addressing

|              |             | Top Boot          |               |              | Вс      | ottom Boot |                   |
|--------------|-------------|-------------------|---------------|--------------|---------|------------|-------------------|
| Size<br>(KW) | 16 Mbit     | 32 Mbit           | 64 Mbit       | Size<br>(KW) | 16 Mbit | 32 Mbit    | 64 Mbit           |
| 4            | FF000-FFFFF | 1FF000-<br>1FFFFF | 3FF000-3FFFFF | 32           |         |            | 3F8000-<br>3FFFFF |
| 4            | FE000-FEFFF | 1FE000-<br>1FEFFF | 3FE000-3FEFFF | 32           |         |            | 3F0000-<br>3F7FFF |
| 4            | FD000-FDFFF | 1FD000-<br>1FDFFF | 3FD000-3FDFFF | 32           |         |            | 3E8000-<br>3EFFFF |
| 4            | FC000-FCFFF | 1FC000-<br>1FCFFF | 3FC000-3FCFFF | 32           |         |            | 3E0000-<br>3E7FFF |
| 4            | FB000-FBFFF | 1FB000-<br>1FBFFF | 3FB000-3FBFFF | 32           |         |            | 3D8000-<br>3DFFFF |
| 4            | FA000-FAFFF | 1FA000-<br>1FAFFF | 3FA000-3FAFFF | 32           |         |            | 3D0000-<br>3D7FFF |
| 4            | F9000-F9FFF | 1F9000-<br>1F9FFF | 3F9000-3F9FFF | 32           |         |            | 3C8000-<br>3CFFFF |
| 4            | F8000-F8FFF | 1F8000-<br>1F8FFF | 3F8000-3F8FFF | 32           |         |            | 3C0000-<br>3C7FFF |
| 32           | F0000-F7FFF | 1F0000-<br>1F7FFF | 3F0000-3F7FFF | 32           |         |            | 3B8000-<br>3BFFFF |
| 32           | E8000-EFFFF | 1E8000-<br>1EFFFF | 3E8000-3EFFFF | 32           |         |            | 3B0000-<br>3B7FFF |
| 32           | E0000-E7FFF | 1E0000-<br>1E7FFF | 3E0000-3E7FFF | 32           |         |            | 3A8000-<br>3AFFFF |
| 32           | D8000-DFFFF | 1D8000-<br>1DFFFF | 3D8000-3DFFFF | 32           |         |            | 3A0000-<br>3A7FFF |
| 32           | D0000-D7FFF | 1D0000-<br>1D7FFF | 3D0000-3D7FFF | 32           |         |            | 398000-39FFFF     |
| 32           | C8000-CFFFF | 1C8000-<br>1CFFFF | 3C8000-3CFFFF | 32           |         |            | 390000-397FFF     |
| 32           | C0000-C7FFF | 1C0000-<br>1C7FFF | 3C0000-3C7FFF | 32           |         |            | 388000-38FFFF     |
| 32           | B8000-BFFFF | 1B8000-<br>1BFFFF | 3B8000-3BFFFF | 32           |         |            | 380000-387FFF     |



#### Table 6.16-Mbit, 32-Mbit, and 64-Mbit Word-Wide Memory Addressing Map (Sheet 2 of 6)

|              |             | Top Boot          |               |              | Be      | ottom Boot |                   |
|--------------|-------------|-------------------|---------------|--------------|---------|------------|-------------------|
| Size<br>(KW) | 16 Mbit     | 32 Mbit           | 64 Mbit       | Size<br>(KW) | 16 Mbit | 32 Mbit    | 64 Mbit           |
| 32           | B0000-B7FFF | 1B0000-<br>1B7FFF | 3B0000-3B7FFF | 32           |         |            | 378000-37FFFF     |
| 32           | A8000-AFFFF | 1A8000-<br>1AFFFF | 3A8000-3AFFFF | 32           |         |            | 370000-377FFF     |
| 32           | A0000-A7FFF | 1A0000-<br>1A7FFF | 3A0000-3A7FFF | 32           |         |            | 368000-36FFFF     |
| 32           | 98000-9FFFF | 198000-<br>19FFFF | 398000-39FFFF | 32           |         |            | 360000-367FFF     |
| 32           | 90000-97FFF | 190000-<br>197FFF | 390000-397FFF | 32           |         |            | 358000-35FFFF     |
| 32           | 88000-8FFFF | 188000-<br>18FFFF | 388000-38FFFF | 32           |         |            | 350000-357FFF     |
| 32           | 80000-87FFF | 180000-<br>187FFF | 380000-387FFF | 32           |         |            | 348000-34FFFF     |
| 32           | 78000-7FFFF | 178000-<br>17FFFF | 378000-37FFFF | 32           |         |            | 340000-347FFF     |
| 32           | 70000-77FFF | 170000-<br>177FFF | 370000-377FFF | 32           |         |            | 338000-33FFFF     |
| 32           | 68000-6FFFF | 168000-<br>16FFFF | 368000-36FFFF | 32           |         |            | 330000-337FFF     |
| 32           | 60000-67FFF | 160000-<br>167FFF | 360000-367FFF | 32           |         |            | 328000-32FFFF     |
| 32           | 58000-5FFFF | 158000-<br>15FFFF | 358000-35FFFF | 32           |         |            | 320000-327FFF     |
| 32           | 50000-57FFF | 150000-<br>157FFF | 350000-357FFF | 32           |         |            | 318000-31FFFF     |
| 32           | 48000-4FFFF | 148000-<br>14FFFF | 348000-34FFFF | 32           |         |            | 310000-317FFF     |
| 32           | 40000-47FFF | 140000-<br>147FFF | 340000-347FFF | 32           |         |            | 308000-30FFFF     |
| 32           | 38000-3FFFF | 138000-<br>13FFFF | 338000-33FFFF | 32           |         |            | 300000-307FFF     |
| 32           | 30000-37FFF | 130000-<br>137FFF | 330000-337FFF | 32           |         |            | 2F8000-<br>2FFFFF |
| 32           | 28000-2FFFF | 128000-<br>12FFFF | 328000-32FFFF | 32           |         |            | 2F0000-<br>2F7FFF |
| 32           | 20000-27FFF | 120000-<br>127FFF | 320000-327FFF | 32           |         |            | 2E8000-<br>2EFFFF |
| 32           | 18000-1FFFF | 118000-11FFFF     | 318000-31FFFF | 32           |         |            | 2E0000-<br>2E7FFF |
| 32           | 10000-17FFF | 110000-117FFF     | 310000-317FFF | 32           |         |            | 2D8000-<br>2DFFFF |

#### 16-Mbit, 32-Mbit, and 64-Mbit Word-Wide Memory Addressing

18 Aug 2005 16

#### Table 6. 16-Mbit, 32-Mbit, and 64-Mbit Word-Wide Memory Addressing Map (Sheet 3 of 6)

|              |             | Top Boot          |               |              | ae memory Addres | ottom Boot |                   |
|--------------|-------------|-------------------|---------------|--------------|------------------|------------|-------------------|
| Size<br>(KW) | 16 Mbit     | 32 Mbit           | 64 Mbit       | Size<br>(KW) | 16 Mbit          | 32 Mbit    | 64 Mbit           |
| 32           | 08000-0FFFF | 108000-<br>10FFFF | 308000-30FFFF | 32           |                  |            | 2D0000-<br>2D7FFF |
| 32           | 00000-07FFF | 100000-<br>107FFF | 300000-307FFF | 32           |                  |            | 2C8000-<br>2CFFFF |
| 32           |             | 0F8000-<br>0FFFFF | 2F8000-2FFFFF | 32           |                  |            | 2C0000-<br>2C7FFF |
| 32           |             | 0F0000-<br>0F7FFF | 2F0000-2F7FFF | 32           |                  |            | 2B8000-<br>2BFFFF |
| 32           |             | 0E8000-<br>0EFFFF | 2E8000-2EFFFF | 32           |                  |            | 2B0000-<br>2B7FFF |
| 32           |             | 0E0000-<br>0E7FFF | 2E0000-2E7FFF | 32           |                  |            | 2A8000-<br>2AFFFF |
| 32           |             | 0D8000-<br>0DFFFF | 2D8000-2DFFFF | 32           |                  |            | 2A0000-<br>2A7FFF |
| 32           |             | 0D0000-<br>0D7FFF | 2D0000-2D7FFF | 32           |                  |            | 298000-29FFFF     |
| 32           |             | 0C8000-<br>0CFFFF | 2C8000-2CFFFF | 32           |                  |            | 290000-297FFF     |
| 32           |             | 0C0000-<br>0C7FFF | 2C0000-2C7FFF | 32           |                  |            | 288000-28FFFF     |
| 32           |             | 0B8000-<br>0BFFFF | 2B8000-2BFFFF | 32           |                  |            | 280000-287FFF     |
| 32           |             | 0B0000-<br>0B7FFF | 2B0000-2B7FFF | 32           |                  |            | 278000-27FFFF     |
| 32           |             | 0A8000-<br>0AFFFF | 2A8000-2AFFFF | 32           |                  |            | 270000-277FFF     |
| 32           |             | 0A0000-<br>0A7FFF | 2A0000-2A7FFF | 32           |                  |            | 268000-26FFFF     |
| 32           |             | 098000-<br>09FFFF | 298000-29FFFF | 32           |                  |            | 260000-267FFF     |
| 32           |             | 090000-<br>097FFF | 290000-297FFF | 32           |                  |            | 258000-25FFFF     |
| 32           |             | 088000-<br>08FFFF | 288000-28FFFF | 32           |                  |            | 250000-257FFF     |
| 32           |             | 080000-<br>087FFF | 280000-287FFF | 32           |                  |            | 248000-24FFFF     |
| 32           |             | 078000-<br>07FFFF | 278000-27FFFF | 32           |                  |            | 240000-247FFF     |
| 32           |             | 070000-<br>077FFF | 270000-277FFF | 32           |                  |            | 238000-23FFFF     |
| 32           |             | 068000-<br>06FFFF | 268000-26FFFF | 32           |                  |            | 230000-237FFF     |

#### 16-Mbit, 32-Mbit, and 64-Mbit Word-Wide Memory Addressing



#### Table 6. 16-Mbit, 32-Mbit, and 64-Mbit Word-Wide Memory Addressing Map (Sheet 4 of 6)

|              |         | Top Boot          |               |              | B       | ottom Boot        |                   |
|--------------|---------|-------------------|---------------|--------------|---------|-------------------|-------------------|
| Size<br>(KW) | 16 Mbit | 32 Mbit           | 64 Mbit       | Size<br>(KW) | 16 Mbit | 32 Mbit           | 64 Mbit           |
| 32           |         | 060000-<br>067FFF | 260000-267FFF | 32           |         |                   | 228000-22FFFF     |
| 32           |         | 058000-<br>05FFFF | 258000-25FFFF | 32           |         |                   | 220000-227FFF     |
| 32           |         | 050000-<br>057FFF | 250000-257FFF | 32           |         |                   | 218000-21FFFF     |
| 32           |         | 048000-<br>04FFFF | 248000-24FFFF | 32           |         |                   | 210000-217FFF     |
| 32           |         | 040000-<br>047FFF | 240000-247FFF | 32           |         |                   | 208000-20FFFF     |
| 32           |         | 038000-<br>03FFFF | 238000-23FFFF | 32           |         |                   | 200000-207FFF     |
| 32           |         | 030000-<br>037FFF | 230000-237FFF | 32           |         | 1F8000-<br>1FFFFF | 1F8000-<br>1FFFFF |
| 32           |         | 028000-<br>02FFFF | 228000-22FFFF | 32           |         | 1F0000-<br>1F7FFF | 1F0000-<br>1F7FFF |
| 32           |         | 020000-<br>027FFF | 220000-227FFF | 32           |         | 1E8000-<br>1EFFFF | 1E8000-<br>1EFFFF |
| 32           |         | 018000-<br>01FFFF | 218000-21FFFF | 32           |         | 1E0000-<br>1E7FFF | 1E0000-<br>1E7FFF |
| 32           |         | 010000-<br>017FFF | 210000-217FFF | 32           |         | 1D8000-<br>1DFFFF | 1D8000-<br>1DFFFF |
| 32           |         | 008000-<br>00FFFF | 208000-21FFFF | 32           |         | 1D0000-<br>1D7FFF | 1D0000-<br>1D7FFF |
| 32           |         | 000000-<br>007FFF | 200000-207FFF | 32           |         | 1C8000-<br>1CFFFF | 1C8000-<br>1CFFFF |
| 32           |         |                   | 1F8000-1FFFFF | 32           |         | 1C0000-<br>1C7FFF | 1C0000-<br>1C7FFF |
| 32           |         |                   | 1F0000-1F7FFF | 32           |         | 1B8000-<br>1BFFFF | 1B8000-<br>1BFFFF |
| 32           |         |                   | 1E8000-1EFFFF | 32           |         | 1B0000-<br>1B7FFF | 1B0000-<br>1B7FFF |
| 32           |         |                   | 1E0000-1E7FFF | 32           |         | 1A8000-<br>1AFFFF | 1A8000-<br>1AFFFF |
| 32           |         |                   | 1D8000-1DFFFF | 32           |         | 1A0000-<br>1A7FFF | 1A0000-<br>1A7FFF |
| 32           |         |                   | 1D0000-1D7FFF | 32           |         | 198000-19FFFF     | 198000-19FFFF     |
| 32           |         |                   | 1C8000-1CFFFF | 32           |         | 190000-197FFF     | 190000-197FFF     |
| 32           |         |                   | 1C0000-1C7FFF | 32           |         | 188000-18FFFF     | 188000-18FFFF     |
| 32           |         |                   | 1B8000-1BFFFF | 32           |         | 180000-187FFF     | 180000-187FFF     |
| 32           |         |                   | 1B0000-1B7FFF | 32           |         | 178000-17FFFF     | 178000-17FFFF     |
| 32           |         |                   | 1A8000-1AFFFF | 32           |         | 170000-177FFF     | 170000-177FFF     |

#### 16-Mbit, 32-Mbit, and 64-Mbit Word-Wide Memory Addressing

18 Aug 2005 18

#### Table 6. 16-Mbit, 32-Mbit, and 64-Mbit Word-Wide Memory Addressing Map (Sheet 5 of 6)

|              |         | Top Boot |               |              | B           | ottom Boot    |               |
|--------------|---------|----------|---------------|--------------|-------------|---------------|---------------|
| Size<br>(KW) | 16 Mbit | 32 Mbit  | 64 Mbit       | Size<br>(KW) | 16 Mbit     | 32 Mbit       | 64 Mbit       |
| 32           |         |          | 1A0000-1A7FFF | 32           |             | 168000-16FFFF | 168000-16FFFF |
| 32           |         |          | 198000-19FFFF | 32           |             | 160000-167FFF | 160000-167FFF |
| 32           |         |          | 190000-197FFF | 32           |             | 158000-15FFFF | 158000-15FFFF |
| 32           |         |          | 188000-18FFFF | 32           |             | 150000-157FFF | 150000-157FFF |
| 32           |         |          | 180000-187FFF | 32           |             | 148000-14FFFF | 148000-14FFFF |
| 32           |         |          | 178000-17FFFF | 32           |             | 140000-147FFF | 140000-147FFF |
| 32           |         |          | 170000-177FFF | 32           |             | 138000-13FFFF | 138000-13FFFF |
| 32           |         |          | 168000-16FFFF | 32           |             | 130000-137FFF | 130000-137FFF |
| 32           |         |          | 160000-167FFF | 32           |             | 128000-12FFFF | 128000-12FFFF |
| 32           |         |          | 158000-15FFFF | 32           |             | 120000-127FFF | 120000-127FFF |
| 32           |         |          | 150000-157FFF | 32           |             | 118000-11FFFF | 118000-11FFFF |
| 32           |         |          | 148000-14FFFF | 32           |             | 110000-117FFF | 110000-117FFF |
| 32           |         |          | 140000-147FFF | 32           |             | 108000-10FFFF | 108000-10FFFF |
| 32           |         |          | 138000-13FFFF | 32           |             | 100000-107FFF | 100000-107FFF |
| 32           |         |          | 130000-137FFF | 32           | F8000-FFFFF | F8000-FFFFF   | F8000-FFFFF   |
| 32           |         |          | 128000-12FFFF | 32           | F0000-F7FFF | F0000-F7FFF   | F0000-F7FFF   |
| 32           |         |          | 120000-127FFF | 32           | E8000-EFFFF | E8000-EFFFF   | E8000-EFFFF   |
| 32           |         |          | 118000-11FFFF | 32           | E0000-E7FFF | E0000-E7FFF   | E0000-E7FFF   |
| 32           |         |          | 110000-117FFF | 32           | D8000-DFFFF | D8000-DFFFF   | D8000-DFFFF   |
| 32           |         |          | 108000-10FFFF | 32           | D0000-D7FFF | D0000-D7FFF   | D0000-D7FFF   |
| 32           |         |          | 100000-107FFF | 32           | C8000-CFFFF | C8000-CFFFF   | C8000-CFFFF   |
| 32           |         |          | 0F8000-0FFFFF | 32           | C0000-C7FFF | C0000-C7FFF   | C0000-C7FFF   |
| 32           |         |          | 0F0000-0F7FFF | 32           | B8000-BFFFF | B8000-BFFFF   | B8000-BFFFF   |
| 32           |         |          | 0E8000-0EFFFF | 32           | B0000-B7FFF | B0000-B7FFF   | B0000-B7FFF   |
| 32           |         |          | 0E0000-0E7FFF | 32           | A8000-AFFFF | A8000-AFFFF   | A8000-AFFFF   |
| 32           |         |          | 0D8000-0DFFFF | 32           | A0000-A7FFF | A0000-A7FFF   | A0000-A7FFF   |
| 32           |         |          | 0D0000-0D7FFF | 32           | 98000-9FFFF | 98000-9FFFF   | 98000-9FFFF   |
| 32           |         |          | 0C8000-0CFFFF | 32           | 90000-97FFF | 90000-97FFF   | 90000-97FFF   |
| 32           |         |          | 0C0000-0C7FFF | 32           | 88000-8FFFF | 88000-8FFFF   | 88000-8FFFF   |
| 32           |         |          | 0B8000-0BFFFF | 32           | 80000-87FFF | 80000-87FFF   | 80000-87FFF   |
| 32           |         |          | 0B0000-0B7FFF | 32           | 78000-7FFFF | 78000-7FFFF   | 78000-7FFFF   |
| 32           |         |          | 0A8000-0AFFFF | 32           | 70000-77FFF | 70000-77FFF   | 70000-77FFF   |
| 32           |         |          | 0A0000-0A7FFF | 32           | 68000-6FFFF | 68000-6FFFF   | 68000-6FFFF   |
| 32           |         |          | 098000-09FFFF | 32           | 60000-67FFF | 60000-67FFF   | 60000-67FFF   |
| 32           |         |          | 090000-097FFF | 32           | 58000-5FFFF | 58000-5FFFF   | 58000-5FFFF   |

#### 16-Mbit, 32-Mbit, and 64-Mbit Word-Wide Memory Addressing



#### Table 6. 16-Mbit, 32-Mbit, and 64-Mbit Word-Wide Memory Addressing Map (Sheet 6 of 6)

|              |         |          |               |              | de Memory Addres   | 5           |             |
|--------------|---------|----------|---------------|--------------|--------------------|-------------|-------------|
|              |         | Top Boot |               |              | Bo                 | ottom Boot  |             |
| Size<br>(KW) | 16 Mbit | 32 Mbit  | 64 Mbit       | Size<br>(KW) | 16 Mbit 32 Mbit 64 |             | 64 Mbit     |
| 32           |         |          | 088000-08FFFF | 32           | 50000-57FFF        | 50000-57FFF | 50000-57FFF |
| 32           |         |          | 080000-087FFF | 32           | 48000-4FFFF        | 48000-4FFFF | 48000-4FFFF |
| 32           |         |          | 078000-07FFFF | 32           | 40000-47FFF        | 40000-47FFF | 40000-47FFF |
| 32           |         |          | 070000-077FFF | 32           | 38000-3FFFF        | 38000-3FFFF | 38000-3FFFF |
| 32           |         |          | 068000-06FFFF | 32           | 30000-37FFF        | 30000-37FFF | 30000-37FFF |
| 32           |         |          | 060000-067FFF | 32           | 28000-2FFFF        | 28000-2FFFF | 28000-2FFFF |
| 32           |         |          | 058000-05FFFF | 32           | 20000-27FFF        | 20000-27FFF | 20000-27FFF |
| 32           |         |          | 050000-057FFF | 32           | 18000-1FFFF        | 18000-1FFFF | 18000-1FFFF |
| 32           |         |          | 048000-04FFFF | 32           | 10000-17FFF        | 10000-17FFF | 10000-17FFF |
| 32           |         |          | 040000-047FFF | 32           | 08000-0FFFF        | 08000-0FFFF | 08000-0FFFF |
| 32           |         |          | 038000-03FFFF | 4            | 07000-07FFF        | 07000-07FFF | 07000-07FFF |
| 32           |         |          | 030000-037FFF | 4            | 06000-06FFF        | 06000-06FFF | 06000-06FFF |
| 32           |         |          | 028000-02FFFF | 4            | 05000-05FFF        | 05000-05FFF | 05000-05FFF |
| 32           |         |          | 020000-027FFF | 4            | 04000-04FFF        | 04000-04FFF | 04000-04FFF |
| 32           |         |          | 018000-01FFFF | 4            | 03000-03FFF        | 03000-03FFF | 03000-03FFF |
| 32           |         |          | 010000-017FFF | 4            | 02000-02FFF        | 02000-02FFF | 02000-02FFF |
| 32           |         |          | 008000-00FFFF | 4            | 01000-01FFF        | 01000-01FFF | 01000-01FFF |
| 32           |         |          | 000000-007FFF | 4            | 00000-00FFF        | 00000-00FFF | 00000-00FFF |

#### 16-Mbit, 32-Mbit, and 64-Mbit Word-Wide Memory Addressing

### 3.2.4 4-Mbit, 8-Mbit, and 16-Mbit Byte-Wide Memory Maps

#### Table 7.8-Mbit and 16-Mbit Byte-Wide Memory Addressing Map (Sheet 1 of 3)

8-Mbit and 16-Mbit Byte-Wide Byte-Wide Memory Addressing

|           | Top Boot    |               | Bottom Boot |        |         |  |  |
|-----------|-------------|---------------|-------------|--------|---------|--|--|
| Size (KB) | 8 Mbit      | 16 Mbit       | Size (KB)   | 8 Mbit | 16 Mbit |  |  |
| 8         | FE000-FFFFF | 1FE000-1FFFFF | 64          |        |         |  |  |
| 8         | FC000-FDFFF | 1FC000-1FDFFF | 64          |        |         |  |  |
| 8         | FA000-FBFFF | 1FA000-1FBFFF | 64          |        |         |  |  |
| 8         | F8000-F9FFF | 1F8000-1F9FFF | 64          |        |         |  |  |
| 8         | F6000-F7FFF | 1F6000-1F7FFF | 64          |        |         |  |  |
| 8         | F4000-F5FFF | 1F4000-1F5FFF | 64          |        |         |  |  |
| 8         | F2000-F3FFF | 1F2000-1F3FFF | 64          |        |         |  |  |
| 8         | F0000-F1FFF | 1F0000-1F1FFF | 64          |        |         |  |  |

#### Table 7.8-Mbit and 16-Mbit Byte-Wide Memory Addressing Map (Sheet 2 of 3)

|           | Top Boot    |               |           | Bottom Boot |               |
|-----------|-------------|---------------|-----------|-------------|---------------|
| Size (KB) | 8 Mbit      | 16 Mbit       | Size (KB) | 8 Mbit      | 16 Mbit       |
| 64        | E0000-EFFFF | 1E0000-1EFFFF | 64        |             |               |
| 64        | D0000-DFFFF | 1D0000-1DFFFF | 64        |             |               |
| 64        | C0000-CFFFF | 1C0000-1CFFFF | 64        |             |               |
| 64        | B0000-BFFFF | 1B0000-1BFFFF | 64        |             |               |
| 64        | A0000-AFFFF | 1A0000-1AFFFF | 64        |             |               |
| 64        | 90000-9FFFF | 190000-19FFFF | 64        |             |               |
| 64        | 80000-8FFFF | 180000-18FFFF | 64        |             |               |
| 64        | 70000-7FFFF | 170000-17FFFF | 64        |             |               |
| 64        | 60000-6FFFF | 160000-16FFFF | 64        |             |               |
| 64        | 50000-5FFFF | 150000-15FFFF | 64        |             |               |
| 64        | 40000-4FFFF | 140000-14FFFF | 64        |             |               |
| 64        | 30000-3FFFF | 130000-13FFFF | 64        |             |               |
| 64        | 20000-2FFFF | 120000-12FFFF | 64        |             |               |
| 64        | 10000-1FFFF | 110000-11FFFF | 64        |             |               |
| 64        | 00000-0FFFF | 100000-10FFFF | 64        |             |               |
| 64        |             | 0F0000-0FFFFF | 64        |             |               |
| 64        |             | 0E0000-0EFFFF | 64        |             |               |
| 64        |             | 0D0000-0DFFFF | 64        |             |               |
| 64        |             | 0C0000-0CFFFF | 64        |             |               |
| 64        |             | 0B0000-0BFFFF | 64        |             |               |
| 64        |             | 0A0000-0AFFFF | 64        |             |               |
| 64        |             | 090000-09FFFF | 64        |             |               |
| 64        |             | 080000-08FFFF | 64        |             |               |
| 64        |             | 070000-07FFFF | 64        |             |               |
| 64        |             | 060000-06FFFF | 64        |             | 1F0000-1FFFFF |
| 64        |             | 050000-05FFFF | 64        |             | 1E0000-1EFFFF |
| 64        |             | 040000-04FFFF | 64        |             | 1D0000-1DFFFF |
| 64        |             | 030000-03FFFF | 64        |             | 1C0000-1CFFFF |
| 64        |             | 020000-02FFFF | 64        |             | 1B0000-1BFFFF |
| 64        |             | 010000-01FFFF | 64        |             | 1A0000-1AFFFF |
| 64        |             | 000000-00FFFF | 64        |             | 190000-19FFFF |
| 64        |             |               | 64        |             | 180000-18FFFF |
| 64        |             |               | 64        |             | 170000-17FFFF |
| 64        |             |               | 64        |             | 160000-16FFFF |
| 64        |             |               | 64        |             | 150000-15FFFF |

#### 8-Mbit and 16-Mbit Byte-Wide Byte-Wide Memory Addressing



#### Table 7.8-Mbit and 16-Mbit Byte-Wide Memory Addressing Map (Sheet 3 of 3)

|           | Top Boot |         |           | Bottom Boot |               |
|-----------|----------|---------|-----------|-------------|---------------|
| Size (KB) | 8 Mbit   | 16 Mbit | Size (KB) | 8 Mbit      | 16 Mbit       |
| 64        |          |         | 64        |             | 140000-14FFFF |
| 64        |          |         | 64        |             | 130000-13FFFF |
| 64        |          |         | 64        |             | 120000-12FFFF |
| 64        |          |         | 64        |             | 110000-11FFFF |
| 64        |          |         | 64        |             | 100000-10FFFF |
| 64        |          |         | 64        | F0000-FFFFF | 0F0000-0FFFFF |
| 64        |          |         | 64        | E0000-EFFFF | 0E0000-0EFFFF |
| 64        |          |         | 64        | D0000-DFFFF | 0D0000-0DFFFF |
| 64        |          |         | 64        | C0000-CFFFF | 0C0000-0CFFFF |
| 64        |          |         | 64        | B0000-BFFFF | 0B0000-0BFFFF |
| 64        |          |         | 64        | A0000-AFFFF | 0A0000-0AFFFF |
| 64        |          |         | 64        | 90000-9FFFF | 090000-09FFFF |
| 64        |          |         | 64        | 80000-8FFFF | 080000-08FFFF |
| 64        |          |         | 64        | 70000-7FFFF | 070000-07FFFF |
| 64        |          |         | 64        | 60000-6FFFF | 060000-06FFFF |
| 64        |          |         | 64        | 50000-5FFFF | 050000-05FFFF |
| 64        |          |         | 64        | 40000-4FFFF | 040000-04FFFF |
| 64        |          |         | 64        | 30000-3FFFF | 030000-03FFFF |
| 64        |          |         | 64        | 20000-2FFFF | 020000-02FFFF |
| 64        |          |         | 64        | 10000-1FFFF | 010000-01FFFF |
| 64        |          |         | 8         | 0E000-0FFFF | 00E000-00FFFF |
| 64        |          |         | 8         | 0C000-0DFFF | 00C000-00DFFF |
| 64        |          |         | 8         | 0A000-0BFFF | 00A000-00BFFF |
| 64        |          |         | 8         | 08000-09FFF | 008000-009FFF |
| 64        |          |         | 8         | 06000-07FFF | 006000-007FFF |
| 64        |          |         | 8         | 04000-05FFF | 004000-005FFF |
| 64        |          |         | 8         | 02000-03FFF | 002000-003FFF |
| 64        |          |         | 8         | 00000-01FFF | 000000-001FFF |

8-Mbit and 16-Mbit Byte-Wide Byte-Wide Memory Addressing

#### Table 8. 4-Mbit Byte Wide Memory Addressing Map

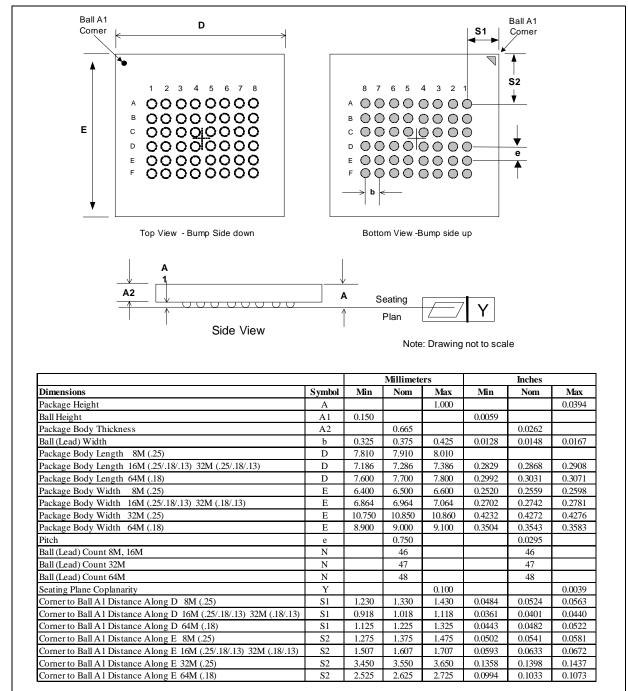
#### 4-Mbit Byte-Wide Memory Addressing

|              |             | Top Boot |              | E           | Sottom Boot |
|--------------|-------------|----------|--------------|-------------|-------------|
| Size<br>(KB) | 4 Mbit      |          | Size<br>(KB) | 4 Mbit      |             |
| 8            | 7E000-7FFFF |          | 64           | 70000-7FFFF |             |
| 8            | 7C000-7DFFF |          | 64           | 60000-6FFFF |             |
| 8            | 7A000-7BFFF |          | 64           | 50000-5FFFF |             |
| 8            | 78000-79FFF |          | 64           | 40000-4FFFF |             |
| 8            | 76000-77FFF |          | 64           | 30000-3FFFF |             |
| 8            | 74000-75FFF |          | 64           | 20000-2FFFF |             |
| 8            | 72000-73FFF |          | 64           | 10000-1FFFF |             |
| 8            | 70000-71FFF |          | 8            | 0E000-0FFFF |             |
| 64           | 60000-6FFFF |          | 8            | 0C000-0DFFF |             |
| 64           | 50000-5FFFF |          | 8            | 0A000-0BFFF |             |
| 64           | 40000-4FFFF |          | 8            | 08000-09FFF |             |
| 64           | 30000-3FFFF |          | 8            | 06000-07FFF |             |
| 64           | 20000-2FFFF |          | 8            | 04000-05FFF |             |
| 64           | 10000-1FFFF |          | 8            | 02000-03FFF |             |
| 64           | 00000-0FFFF |          | 8            | 00000-01FFF |             |

# 4.0 Package Information

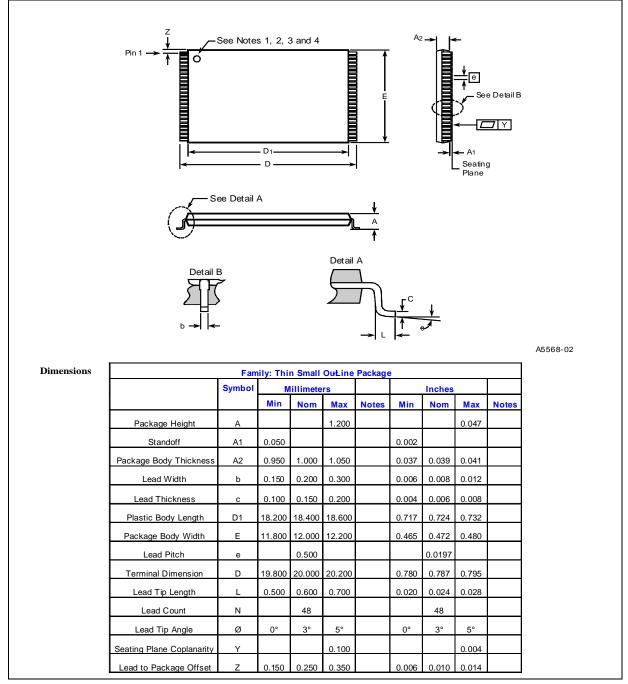
### 4.1 μBGA\* and Very Thin Profile Fine Pitch Ball Grid Array (VF BGA) Package

#### Figure 2. µBGA\* and VF BGA Package Drawing



# 4.2 TSOP Package

#### Figure 3. TSOP Package Drawing



#### Notes: 1.

One dimple on package denotes Pin 1.

2. If two dimples, then the larger dimple denotes Pin 1.

3. Pin 1 is in the upper left corner of the package, in reference to the product mark.

#### Datasheet

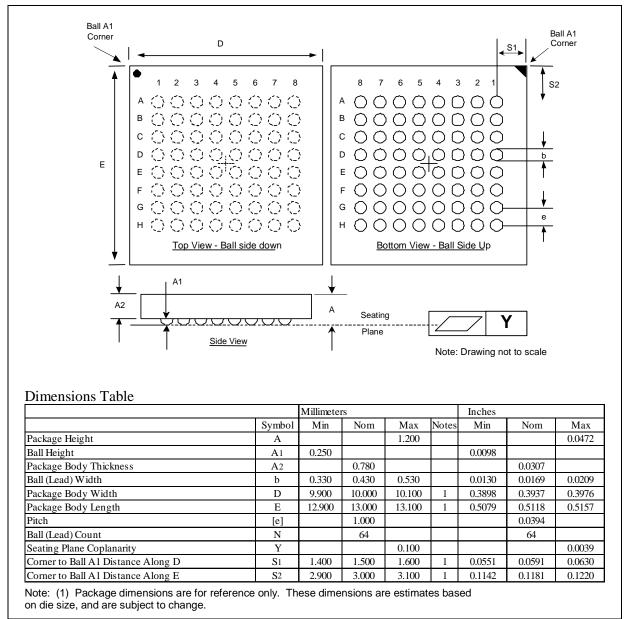
Intel<sup>®</sup> Advanced Boot Block Flash Memory (B3) Order Number: 290580, Revision: 020

Downloaded from Arrow.com.



# 4.3 Easy BGA Package





#### 5.0 **Pinout and Signal Descriptions**

This section explains the package pinout and signal descriptions.

#### **Signal Pinouts** 5.1

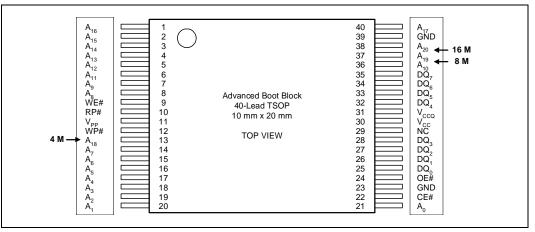
intel

The B3 flash memory device is available in the following packages:

- 40-lead TSOP (x8, Figure 5).
- 48-lead TSOP (x16, Figure 6).
- 48-ball µBGA (x8 in Figure 8 and x16 in Figure 9).
- 48-ball VF BGA (x16, Figure 9).

#### 5.1.1 40-Lead and 48-Lead TSOP Packages

#### Figure 5. 40-Lead TSOP Package for x8 Configurations



Notes:

40-Lead TSOP available for 8-Mbit and 16-Mbit densities only.

1. 2. Lower densities have NC on the upper address pins. For example, an 8-Mbit device has NC on Pin 38.



#### Figure 6. 48-Lead TSOP Package for x16 Configurations

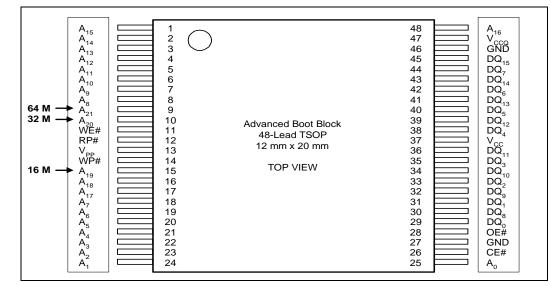
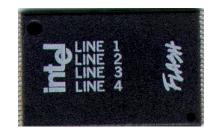
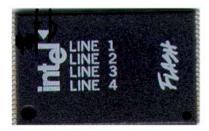


Figure 7. New Mark for Pin-1 Indicator: 40-Lead 8/16 Mb TSOP and 48-Lead 8/16/32 Mb TSOP



New Mark:



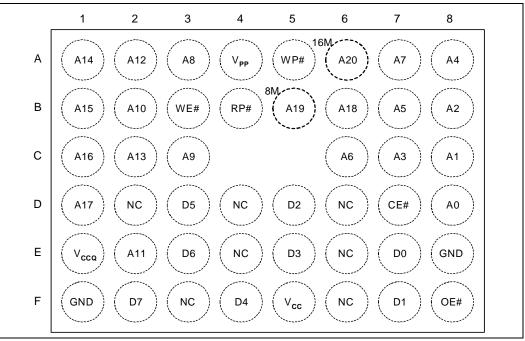
*Note:* The topside marking on 8-Mb, 16-Mb, and 32-Mb Intel<sup>®</sup> Advanced Boot Block 40L and 48L TSOP products changed to a white ink triangle as a Pin-1 indicator. Products without the white triangle continue to use a dimple as a Pin-1 indicator. No other changes were made in package size, materials, functionality, customer handling, or manufacturability. The product continues to meet stringent Intel quality requirements. Table 9 lists the ordering codes of the affected products. See also Table 34 "Ordering Information: Valid Combinations" on page 70.

Intel<sup>®</sup> Advanced Boot Block Flash Memory (B3) Order Number: 290580, Revision: 020

|                       | Ordering Information Valid Combinations |                 |                 |                 |  |  |  |  |  |  |
|-----------------------|---|-----------------|-----------------|-----------------|--|--|--|--|--|--|
|                       | 40-Lead TSOP                            | 48-Lead TSOP    |                 |                 |  |  |  |  |  |  |
| Ext. Temp. 64<br>Mbit |   |                 | TE28F640B3TC70  | TE28F640B3BC70  |  |  |  |  |  |  |
|                       |   |                 | TE28F320B3TD70  | TE28F320B3BD70  |  |  |  |  |  |  |
|                       |   |                 | TE28F320B3TC70  | TE28F320B3BC70  |  |  |  |  |  |  |
| Ext. Temp. 32<br>Mbit |   |                 | TE28F320B3TC90  | TE28F320B3BC90  |  |  |  |  |  |  |
|                       |   |                 | TE28F320B3TA100 | TE28F320B3BA100 |  |  |  |  |  |  |
|                       |   |                 | TE28F320B3TA110 | TE28F320B3BA110 |  |  |  |  |  |  |
|                       |   |                 | TE28F160B3TC70  | TE28F160B3BC70  |  |  |  |  |  |  |
| Ext. Temp. 16         |   |                 | TE28F160B3TC80  | TE28F160B3BC80  |  |  |  |  |  |  |
| Mbit                  | TE28F016B3TA90                          | TE28F016B3BA90  | TE28F160B3TA90  | TE28F160B3BA90  |  |  |  |  |  |  |
|                       | TE28F016B3TA110                         | TE28F016B3BA110 | TE28F160B3TA110 | TE28F160B3BA110 |  |  |  |  |  |  |
| Ext. Temp. 8          | TE28F008B3TA90                          | TE28F008B3BA90  | TE28F800B3TA90  | TE28F800B3BA90  |  |  |  |  |  |  |
| Mbit                  | TE28F008B3TA110                         | TE28F008B3BA110 | TE28F800B3TA110 | TE28F800B3BA110 |  |  |  |  |  |  |

#### Table 9. B3 Flash Memory Device Ordering Information

Figure 8. x8 48-Ball µBGA\* Chip Size Package (Top View, Ball Down)

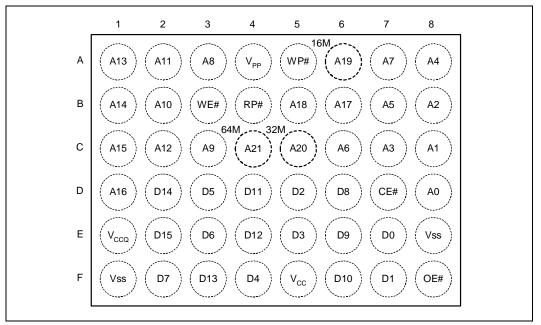


Notes:

1.

A19 and A20 indicate the upgrade address connections. Lower density devices do not have the upper address solder balls. Do not route is not done in this area. A<sub>20</sub> is the upgrade address for the 16-Mbit device.





#### Figure 9. x16 48-Ball VF BGA and µBGA\* Chip Size Package (Top View, Ball Down)

**Notes:** 1.

- A19, A20, and A21 indicate the upgrade address connections. Lower density devices do not have the upper address solder balls. Do not route in this area.
  - $-\dot{A}_{19}$  is the upgrade address for the 16-Mbit device.
  - $-A_{20}$  is the upgrade address for the 32-Mbit device.
  - $-A_{21}^{20}$  is the upgrade address for the 64-Mbit device.
- 2. Table 10 "B3 Flash memory Device Signal Descriptions" on page 31 details the usage of each device pin.

# 5.2 Signal Descriptions

Table 10 describes the active signals.

| Table 10.         B3 Flash memory Device Signal Descriptions (She | neet 1 of 2) |
|---|--------------|
|---|--------------|

| A <sub>0</sub> -A <sub>21</sub> ADDRESS INPUTS for memory addresses. Addresses are internally latched during a program or area cyclo.           A <sub>0</sub> -A <sub>21</sub> Input         SPE00B3: A[0-19]. 28F16B3: A[0-20]. 28F46403: A[0-2]. 28F46463: A[0-2]. 28F464630: A[0-2]. 28F46463: A[0-2]. 28F46463: A[0-2]. 28F46 | Symbol                            | Туре  | Description   |
|--|-----------------------------------|-------|---|
| DQ <sub>0</sub> -DQ <sub>7</sub> Input/<br>Output         Program command.           DQ <sub>0</sub> -DQ <sub>7</sub> Input/<br>Output         Input/<br>outputs array, identifier and Status Register data. The data pins float to tristate when the chip<br>is deselected or the outputs are disabled.           DQ <sub>8</sub> -DQ <sub>15</sub> Input/<br>Output         DATA INPUTSOUTPUTS:           Input/<br>Outputs         Input/<br>Outputs array and identifier data. The data pins float to tristate when the chip is de-selected.<br>Not included on x8 products.           CE#         Input         CHP ENABLE: Activates the internal control logic, input buffers, decoders, and sense amplifiers.<br>CE# is active low. CE# high de-selects the memory device and reduces power consumption to<br>standby levels.           OE#         Input         OUTPUT ENABLE: Enables the flash memory device outputs through the data buffers during a<br>Read operation. OE# is active low.           WE#         Input         WRTITE ENABLE: Controls writes to the Command Register and memory array. WE# is active<br>low. Addresses and data are latched on the rising edge of the second WE# pulse.           RP#         Input         RESET/DEEP POWER-DOWN: Uses two voltage levels (V <sub>IL</sub> , V <sub>H</sub> ) to control reset/deep power-<br>down mode.           WP#         Input         WRITE ENABLE: Controls writes to the Compary device is in reset/deep power-<br>down mode.           WP#         Input         WRITE PROTECT: Locks and unlocks the two lockable parameter blocks.           WP#         WRITE PROTECT: Locks and unlocks the two lockable parameter blocks.<br>SR: 1 and either SR:4 [progra  | A <sub>0</sub> -A <sub>21</sub>   | Input | erase cycle.<br>28F008B3: A[0-19], 28F016B3: A[0-20],<br>28F800B3: A[0-18], 28F160B3: A[0-19],  |
| DQ <sub>8</sub> -DQ <sub>15</sub> Input<br>Output         Inputs array data on the second CE# and WE# cycle during a Program command. Data is<br>internally latched.           CE#         Outputs array and identifier data. The data pins float to tristate when the chip is de-selected.<br>Not included on x8 products.           CE#         Input         CHIP ENABLE: Activates the internal control logic, input buffers, decoders, and sense amplifiers.<br>CE# is active low. CE# high de-selects the memory device and reduces power consumption to<br>standby levels.           OE#         Input         OUTPUT ENABLE: Enables the flash memory device outputs through the data buffers during a<br>Read operation. OE# is active low.           WE#         Input         WRITE ENABLE: Controls writes to the Command Register and memory array. WE# is active<br>low. Addresses and data are latched on the rising edge of the second WE# pulse.           RP#         Input         RESET/DEEP POWER-DOWN: Uses two voltage levels (V <sub>IL</sub> , V <sub>IH</sub> ) to control reset/deep power-<br>down mode.           WP#         Input         RESET/DEEP POWER-DOWN: Uses two voltage levels (V <sub>IL</sub> , V <sub>IH</sub> ) to control reset/deep power-down mode,<br>which drives the outputs to High-Z, resets the Write State Machine, and minimizes current<br>levels (I <sub>CCD</sub> ).           WP#         Input         WRITE PROTECT: Locks and unlocks the two lockable parameter blocks.           WP#         When WP# is at logic low, the lockable blocks are locked, preventing Program and Erase<br>operations to those blocks. If a Program or Erase operation is attempted on a locked block,<br>SR.1 and either SR.4 [program] or SR.5 [erase] are set to indicate the operation failed.  | DQ <sub>0</sub> -DQ <sub>7</sub>  |       | <ul> <li>Program command.</li> <li>Inputs commands to the Command User Interface when CE# and WE# are active. Data is internally latched.</li> <li>Outputs array, identifier and Status Register data. The data pins float to tristate when the chip</li> </ul>   |
| CE#       Input       CE# is active low. CE# high de-selects the memory device and reduces power consumption to standby levels.         OE#       Input       OUTPUT ENABLE: Enables the flash memory device outputs through the data buffers during a Read operation. OE# is active low.         WE#       Input       WRITE ENABLE: Controls writes to the Command Register and memory array. WE# is active low. Addresses and data are latched on the rising edge of the second WE# pulse.         RP#       Input       RESET/DEEP POWER-DOWN: Uses two voltage levels (V <sub>IL</sub> , V <sub>IH</sub> ) to control reset/deep power-down mode.         NP#       Input       When RP# is at logic low, the flash memory device is in reset/deep power-down mode, which drives the outputs to High-Z, resets the Write State Machine, and minimizes current levels (I <sub>CCD</sub> ).         WP#       Input       WRITE PROTECT: Locks and unlocks the two lockable parameter blocks.         WP#       Input       WRITE PROTECT: Locks and unlocks the two lockable parameter blocks.         WP#       WP#       WRH is at logic low, the lockable blocks are locked, preventing Program and Erase operations to those blocks. If a Program or Erase operation is attempted on a locked block, SR.1 and either SR.4 [program] or SR.5 [erase] are set to indicate the operation failed.         Vccq       Input       UTFUT V <sub>cC</sub> : Enables all outputs to be driven to 1.8 V to 2.5 V while the V <sub>cC</sub> is at 2.7 V to 3.3 V.         UP#       Input       Input       The Num WP# is at logic low, the lockable blocks are unlocked and can be programmed or erased.   | DQ <sub>8</sub> -DQ <sub>15</sub> |       | <ul> <li>Inputs array data on the second CE# and WE# cycle during a Program command. Data is internally latched.</li> <li>Outputs array and identifier data. The data pins float to tristate when the chip is de-selected.</li> </ul>   |
| OE#         Input         Read operation. OE# is active low.           WE#         Input         WRITE ENABLE: Controls writes to the Command Register and memory array. WE# is active low. Addresses and data are latched on the rising edge of the second WE# pulse.           RP#         Input         RESET/DEEP POWER-DOWN: Uses two voltage levels (V <sub>IL</sub> , V <sub>IH</sub> ) to control reset/deep power-down mode.           When RP# is at logic low, the flash memory device is in reset/deep power-down mode.         • When RP# is at logic high, the flash memory device is in standard operation. When RP# transitions from logic-low to logic-high, the flash memory device is in standard operation. When RP# transitions from logic-low to logic-high, the flash memory device defaults to the read array mode.           WP#         Input         WRITE PROTECT: Locks and unlocks the two lockable parameter blocks.           WP#         Input         WRITE PROTECT: Locks and unlocks the two lockable parameter blocks.           WP#         Input         WRITE PROTECT: Locks and unlocks the two lockable parameter blocks.           WP#         Input         WRITE PROTECT: Locks and unlocks the two lockable parameter blocks.           When WP# is at logic low, the lockable blocks are locked, preventing Program and Erase operations to those blocks. If a Program or Erase operation is attempted on a locked block, SR.1 and either SR.4 [program] or SR.5 [erase] are set to indicate the operation failed.           When WP# is at logic high, the lockable blocks are unlocked and can be programmed or erased.         See Section 12.0, "Block Locking" on page 62 for d  | CE#                               | Input | CE# is active low. CE# high de-selects the memory device and reduces power consumption to   |
| WE#       Input       low. Addresses and data are latched on the rising edge of the second WE# pulse.         RP#       Input       RESET/DEEP POWER-DOWN: Uses two voltage levels (V <sub>IL</sub> , V <sub>IH</sub> ) to control reset/deep power-down mode.         •       When RP# is at logic low, the flash memory device is in reset/deep power-down mode, which drives the outputs to High-Z, resets the Write State Machine, and minimizes current levels (I <sub>CCD</sub> ).         •       When RP# is at logic high, the flash memory device is in standard operation. When RP# transitions from logic-low to logic-high, the flash memory device defaults to the read array mode.         WP#       Input       WRITE PROTECT: Locks and unlocks the two lockable parameter blocks.         •       When WP# is at logic low, the lockable blocks are locked, preventing Program and Erase operations to those blocks. If a Program or Erase operation is attempted on a locked block, SR.1 and either SR.4 [program] or SR.5 [erase] are set to indicate the operation failed.         •       When WP# is at logic high, the lockable blocks are unlocked and can be programmed or erased.         See Section 12.0, "Block Locking" on page 62 for details on write protection.         V <sub>CCQ</sub> Input         OUTPUT V <sub>CC</sub> : Enables all outputs to be driven to 1.8 V to 2.5 V while the V <sub>CC</sub> is at 2.7 V to 3.3 V.         If the V <sub>CC</sub> is regulated to 2.7 V to 2.85 V, V <sub>CCQ</sub> can be driven at 1.65 V to 2.5 V to achieve lowest power operation (see Section 7.2, "DC Voltage Characteristics" on page 36).         This input can be tied directly to V <sub>CC</sub> (2.7 V to 3.6 V). </td <td>OE#</td> <td>Input</td> <td></td>  | OE#                               | Input |   |
| RP#     Input     When RP# is at logic low, the flash memory device is in reset/deep power-down mode, which drives the outputs to High-Z, resets the Write State Machine, and minimizes current levels (I <sub>CCD</sub> ).       When RP# is at logic high, the flash memory device is in standard operation. When RP# transitions from logic-low to logic-high, the flash memory device defaults to the read array mode.       WP#     Input       WP#     WRITE PROTECT: Locks and unlocks the two lockable parameter blocks.       When WP# is at logic low, the lockable blocks are locked, preventing Program and Erase operations to those blocks. If a Program or Erase operation is attempted on a locked block, SR.1 and either SR.4 [program] or SR.5 [erase] are set to indicate the operation failed.       WP#     When WP# is at logic high, the lockable blocks are unlocked and can be programmed or erased.       See Section 12.0, "Block Locking" on page 62 for details on write protection.       Vccq     Input       Input     OUTPUT V <sub>CC</sub> : Enables all outputs to be driven to 1.8 V to 2.5 V while the V <sub>CC</sub> is at 2.7 V to 3.3 V. If the V <sub>CC</sub> is regulated to 2.7 V to 2.85 V, V <sub>CCQ</sub> can be driven at 1.65 V to 2.5 V to achieve lowest power operation (see Section 7.2, "DC Voltage Characteristics" on page 36). This input can be tied directly to V <sub>CC</sub> (2.7 V to 3.6 V).  | WE#                               | Input |   |
| WP#       Input       • When WP# is at logic low, the lockable blocks are locked, preventing Program and Erase operations to those blocks. If a Program or Erase operation is attempted on a locked block, SR.1 and either SR.4 [program] or SR.5 [erase] are set to indicate the operation failed.         • When WP# is at logic high, the lockable blocks are unlocked and can be programmed or erased.         See Section 12.0, "Block Locking" on page 62 for details on write protection.         V <sub>CCQ</sub> Input         Input       OUTPUT V <sub>CC</sub> : Enables all outputs to be driven to 1.8 V to 2.5 V while the V <sub>CC</sub> is at 2.7 V to 3.3 V. If the V <sub>CC</sub> is regulated to 2.7 V to 2.85 V, V <sub>CCQ</sub> can be driven at 1.65 V to 2.5 V to achieve lowest power operation (see Section 7.2, "DC Voltage Characteristics" on page 36). This input can be tied directly to V <sub>CC</sub> (2.7 V to 3.6 V).   | RP#                               | Input | <ul> <li>down mode.</li> <li>When RP# is at logic low, the flash memory device is in reset/deep power-down mode, which drives the outputs to High-Z, resets the Write State Machine, and minimizes current levels (I<sub>CCD</sub>).</li> <li>When RP# is at logic high, the flash memory device is in standard operation. When RP# transitions from logic-low to logic-high, the flash memory device defaults to the read</li> </ul> |
| VInputIf the VVCCQCCQCan be driven at 1.65 V to 2.5 V to achieve lowest<br>power operation (see Section 7.2, "DC Voltage Characteristics" on page 36).This input can be tied directly to VCC (2.7 V to 3.6 V).   | WP#                               | Input | <ul> <li>When WP# is at logic low, the lockable blocks are locked, preventing Program and Erase operations to those blocks. If a Program or Erase operation is attempted on a locked block, SR.1 and either SR.4 [program] or SR.5 [erase] are set to indicate the operation failed.</li> <li>When WP# is at logic high, the lockable blocks are unlocked and can be programmed or erased.</li> </ul>                                 |
|  | V <sub>CCQ</sub>                  | Input | If the V <sub>CC</sub> is regulated to 2.7 V to 2.85 V, V <sub>CCQ</sub> can be driven at 1.65 V to 2.5 V to achieve lowest power operation (see Section 7.2, "DC Voltage Characteristics" on page 36).   |
|  | V <sub>CC</sub>                   | Power | DEVICE Power Supply: 2.7 V to 3.6 V   |



#### Table 10.B3 Flash memory Device Signal Descriptions (Sheet 2 of 2)

| Symbol          | Туре  | Description  |
|-----------------|-------|--|
| V <sub>PP</sub> | Power | <b>PROGRAM/ERASE Power Supply:</b> Supplies power for Program and Erase operations. V <sub>PP</sub> can be the same as V <sub>CC</sub> (2.7 V to 3.6 V) for single supply voltage operation. For fast programming at manufacturing, 11.4 V to 12.6 V can be supplied to V <sub>PP</sub> . This pin cannot be left floating. 11.4 V to 12.6 V can be applied to V <sub>PP</sub> only for a maximum of 1000 cycles on the main blocks and 2500 cycles on the parameter blocks. V <sub>PP</sub> can be connected to 12 V for a total of 80 hours maximum (see Section 13.0, "V <sub>PP</sub> Program and Erase Voltages" on page 63 for details). V <sub>PP &lt; VPPLK</sub> protects memory contents against inadvertent or unintended program and erase commands. |
| GND             | —     | Ground: For all internal circuitry. All ground inputs must be connected.   |
| NC              | —     | No Connect: Pin can be driven or left floating.  |

# 6.0 Maximum Ratings and Operating Conditions

### 6.1 Absolute Maximum Ratings

Warning:

Stressing the flash memory device beyond the Absolute Maximum Ratings in Table 11 can cause permanent damage. These ratings are stress ratings only.

NOTICE: Specifications are subject to change without notice. Verify with your local Intel Sales office that you have the latest datasheet before finalizing a design.

#### Table 11. Absolute Maximum Ratings

| Parameter   | Maximum Rating    | Notes |
|---|-------------------|-------|
| Extended Operating Temperature  |                   |       |
| During Read   | –40 °C to +85 °C  |       |
| During Block Erase and Program  | –40 °C to +85 °C  |       |
| Temperature under Bias  | –40 °C to +85 °C  |       |
| Storage Temperature   | –65 °C to +125 °C |       |
| Voltage On Any Pin (except $V_{\mbox{\scriptsize CC}}$ and $V_{\mbox{\scriptsize PP}})$ with Respect to GND | –0.5 V to +3.7 V  | 1     |
| $V_PP$ Voltage (for Block Erase and Program) with Respect to GND  | –0.5 V to +13.5 V | 1,2,3 |
| $V_{CC}$ and $V_{CCQ}$ Supply Voltage with Respect to GND   | –0.2 V to +3.6 V  |       |
| Output Short Circuit Current  | 100 mA            | 4     |

#### Notes:

1. Minimum DC voltage is -0.5 V on input/output pins. During transitions, this level might undershoot to -2.0 V for periods <20 ns. Maximum DC voltage on input/output pins is  $V_{CC}$  +0.5 V which, during transitions, might overshoot to  $V_{CC}$  +2.0 V for periods <20 ns.

- Maximum DC voltage on V<sub>PP</sub> might overshoot to +14.0 V for periods <20 ns.</li>
   V<sub>PP</sub> Program voltage is typically 1.65 V to 3.6 V. Connection to a 11.4 V to 12.6 V supply can be done for a maximum of 1000 cycles on the main blocks and 2500 cycles on the parameter blocks during program/erase. V<sub>PP</sub> can be connected to 12 V for a total of 80 hours maximum.
- 4. Output shorted for no more than one second. No more than one output shorted at a time.

#### **Operating Conditions** 6.2

Do not operate the flash memory device beyond the Operating Conditions in Table 12. Extended exposure beyond the Operating Conditions can affect device reliability.

#### Table 12. **Temperature and Voltage Operating Conditions**

| Symbol            | Parameter                      | Min     | Мах  | Units  | Notes |
|-------------------|--------------------------------|---------|------|--------|-------|
| T <sub>A</sub>    | Operating Temperature          | -40     | +85  | °C     |       |
| V <sub>CC1</sub>  | V <sub>CC</sub> Supply Voltage | 2.7     | 3.6  | Volts  | 1, 2  |
| V <sub>CC2</sub>  |                                | 3.0     | 3.6  |        | 1, 2  |
| V <sub>CCQ1</sub> |                                | 2.7     | 3.6  |        | 1     |
| V <sub>CCQ2</sub> | I/O Supply Voltage             | 1.65    | 2.5  | Volts  |       |
| V <sub>CCQ3</sub> |                                | 1.8     | 2.5  |        |       |
| V <sub>PP1</sub>  | Supply Voltage                 | 1.65    | 3.6  | Volts  | 1     |
| V <sub>PP2</sub>  |                                | 11.4    | 12.6 | Volts  | 1, 3  |
| Cycling           | Block Erase Cycling            | 100,000 |      | Cycles | 3     |

Notes: 1.

 $V_{CC}$  and  $V_{CCQ}$  must share the same supply when they are in the  $V_{CC1}$  range.  $V_{CC}Max = 3.3$  V for 0.25 $\mu$ m 32-Mbit devices.  $V_{PP} = 11.4$  V-12.6 V can be applied during a program/erase only for a maximum of 1000 cycles on the main blocks and 2500 cycles on the parameter blocks.  $V_{PP}$  can be 2. 3. connected to 12 V for a total of 80 hours maximum.

# 7.0 Electrical Specifications

# 7.1 DC Current Characteristics

|                     | Parameter  | v <sub>cc</sub>    | 2.7 V-      | -3.6 V | 2.7 V-       | 2.85 V | 2.7 V-      | -3.3 V |      |   |  |
|---------------------|--|--------------------|-------------|--------|--------------|--------|-------------|--------|------|---|--|
| Sym                 |  | V <sub>CCQ</sub>   | 2.7 V–3.6 V |        | 1.65 V–2.5 V |        | 1.8 V–2.5 V |        | Unit | Test Conditions   |  |
|                     |  | Note               | Typ Max     |        | Тур Мах      |        | Тур Мах     |        |      |   |  |
| ILI                 | Input Load Current   | 1,2                |             | ± 1    |              | ± 1    |             | ± 1    | μΑ   | $V_{CC} = V_{CC}Max$<br>$V_{CCQ} = V_{CCQ}Max$<br>$V_{IN} = V_{CCQ}$ or GND                       |  |
| I <sub>LO</sub>     | Output Leakage Current   | 1,2                |             | ± 10   |              | ± 10   |             | ± 10   | μA   | $V_{CC} = V_{CC}Max$<br>$V_{CCQ} = V_{CCQ}Max$<br>$V_{IN} = V_{CCQ} \text{ or GND}$               |  |
| I <sub>CCS</sub>    | V <sub>CC</sub> Standby Current for<br>0.13 and 0.18 Micron<br>Product       | 1                  | 7           | 15     | 20           | 50     | 150         | 250    | μA   | V <sub>CC</sub> = V <sub>CC</sub> Max<br>CE# = RP# = V <sub>CCQ</sub><br>or during Program/ Erase |  |
|                     | V <sub>CC</sub> Standby Current for<br>0.25 Micron Product                   | 1                  | 10          | 25     | 20           | 50     | 150         | 250    | μA   | Suspend<br>WP# = V <sub>CCQ</sub> or GND  |  |
| I <sub>CCD</sub>    | V <sub>CC</sub> Power-Down Current<br>for 0.13 and 0.18 Micron<br>Product    | 1,2                | 7           | 15     | 7            | 20     | 7           | 20     | μA   | $V_{CC} = V_{CC}Max$<br>$V_{CCQ} = V_{CCQ}Max$  |  |
| 002                 | V <sub>CC</sub> Power-Down Current<br>for 0.25 Product                       | 1,2                | 7           | 25     | 7            | 25     | 7           | 25     | μA   | $V_{IN} = V_{CCQ}$ or GND<br>RP# = GND ± 0.2 V  |  |
| I <sub>CCR</sub>    | V <sub>CC</sub> Read Current for<br>0.13 and 0.18 Micron<br>Product          | 1,2,3              | 9           | 18     | 8            | 15     | 9           | 15     | mA   | $V_{CC} = V_{CC}Max$<br>$V_{CCQ} = V_{CCQ}Max$<br>$OE\# = V_{IH}, CE\# = V_{IL}$                  |  |
|                     | V <sub>CC</sub> Read Current for<br>0.25 Micron Product                      | 1,2,3              | 10          | 18     | 8            | 15     | 9           | 15     | mA   | $f = 5 \text{ MHz}, I_{OUT}=0 \text{ mA}$<br>Inputs = V <sub>IL</sub> or V <sub>IH</sub>          |  |
| I <sub>PPD</sub>    | V <sub>PP</sub> Deep Power-Down<br>Current                                   | 1                  | 0.2         | 5      | 0.2          | 5      | 0.2         | 5      | μΑ   | $\begin{array}{l} RP\# = GND \pm 0.2 \ V \\ V_{PP} \leq V_{CC} \end{array}$                       |  |
| Iccw                | V <sub>CC</sub> Program Current  | 1,4                | 18          | 55     | 18           | 55     | 18          | 55     | mA   | V <sub>PP</sub> =V <sub>PP1,</sub><br>Program in Progress   |  |
| CCW                 | VCC Hogian ourient   | 1,7                | 8           | 22     | 10           | 30     | 10          | 30     | mA   | $V_{PP} = V_{PP2 (12v)}$<br>Program in Progress   |  |
| I <sub>CCE</sub>    | V <sub>CC</sub> Erase Current  | 1,4                | 16          | 45     | 21           | 45     | 21          | 45     | mA   | V <sub>PP</sub> = V <sub>PP1,</sub><br>Erase in Progress  |  |
| CCE                 |  | .,.                | 8           | 15     | 16           | 45     | 16          | 45     | mA   | V <sub>PP</sub> = V <sub>PP2 (12v)</sub> ,<br>Erase in Progress                                   |  |
| I <sub>CCES</sub> / | V <sub>CC</sub> Erase Suspend<br>Current for 0.13 and 0.18<br>Micron Product | 1,4,5              | 7           | 15     | 50           | 200    | 50          | 200    | μA   | CE# = V <sub>IH,</sub> Erase  |  |
| I <sub>CCWS</sub>   | V <sub>CC</sub> Erase Suspend<br>Current for 0.25 Micron<br>Product          | т, <del>+</del> ,0 | 10          | 25     | 50           | 200    | 50          | 200    | μA   | Suspend in Progress   |  |
| I <sub>PPR</sub>    | V <sub>PP</sub> Read Current   | 1,4                | 2           | ±15    | 2            | ±15    | 2           | ±15    | μΑ   | $V_{PP} \leq V_{CC}$  |  |
| PPR                 |  | 1,4                | 50          | 200    | 50           | 200    | 50          | 200    | μA   | $V_{PP} > V_{CC}$   |  |

#### Table 13.DC Current Characteristics (Sheet 1 of 2)

18 Aug 2005 34

# intط

|                     |  | v <sub>cc</sub>  | 2.7 V-      | -3.6 V | 2.7 V–2.85 V |     | 2.7 V-3.3 V |     |      |   |  |
|---------------------|--|------------------|-------------|--------|--------------|-----|-------------|-----|------|---|--|
| Sym                 | Parameter                                      | V <sub>CCQ</sub> | 2.7 V-3.6 V |        | 1.65 V–2.5 V |     | 1.8 V–2.5 V |     | Unit | Test Conditions   |  |
|                     |  | Note             | Тур         | Max    | Тур          | Max | Тур         | Max |      |   |  |
| 1                   | V <sub>PP</sub> Program Current                | 1,4              | 0.05        | 0.1    | 0.05         | 0.1 | 0.05        | 0.1 | mA   | V <sub>PP</sub> =V <sub>PP1,</sub><br>Program in Progress                             |  |
| I <sub>PPW</sub>    |  |                  | 8           | 22     | 8            | 22  | 8           | 22  | mA   | V <sub>PP</sub> = V <sub>PP2 (12v)</sub><br>Program in Progress                       |  |
| I                   | V <sub>PP</sub> Erase Current                  | 1,4              | 0.05        | 0.1    | 0.05         | 0.1 | 0.05        | 0.1 | mA   | V <sub>PP</sub> = V <sub>PP1,</sub><br>Erase in Progress                              |  |
| IPPE                | I <sub>PPE</sub> V <sub>PP</sub> Erase Current |                  | 8           | 22     | 16           | 45  | 16          | 45  | mA   | $V_{PP} = V_{PP2 (12v)}$ ,<br>Erase in Progress                                       |  |
| I <sub>PPES</sub> / | V <sub>CC</sub> Erase Suspend                  | 1 /              | 0.2         | 5      | 0.2          | 5   | 0.2         | 5   | μA   | V <sub>PP</sub> = V <sub>PP1,</sub><br>Program or Erase<br>Suspend in Progress        |  |
| IPPWS               | Current  | 1,4              | 50          | 200    | 50           | 200 | 50          | 200 | μA   | V <sub>PP</sub> = V <sub>PP2 (12v)</sub> ,<br>Program or Erase<br>Suspend in Progress |  |

#### Table 13. DC Current Characteristics (Sheet 2 of 2)

Notes:

1.

All currents are in RMS unless otherwise noted. Typical values at nominal V<sub>CC</sub>, T<sub>A</sub> = +25 °C. The test conditions V<sub>CC</sub>Max, V<sub>CCQ</sub>Max, V<sub>CC</sub>Min, and V<sub>CCQ</sub>Min refer to the maximum or minimum V<sub>CC</sub> or V<sub>CCQ</sub> voltage listed at the top of each column. V<sub>CC</sub>Max = 3.3 V for 0.25 $\mu$ m 32-Mbit devices. Automatic Power Savings (APS) reduces I<sub>CCR</sub> to approximately standby levels in static operation (CMOS inputs). Sampled, not 100% tested. 2.

3.

4. 5.

 $\begin{array}{l} \mathsf{I}_{\mathsf{CCES}} \text{ or } \mathsf{I}_{\mathsf{CCWS}} \text{ is specified with the flash memory device deselected.} \\ - \text{ If the device is read while in erase suspend, the current draw is the sum of } \mathsf{I}_{\mathsf{CCES}} \text{ and } \mathsf{I}_{\mathsf{CCR}}. \\ - \text{ If the device is read while in program suspend, the current draw is the sum of } \mathsf{I}_{\mathsf{CCWS}} \text{ and } \mathsf{I}_{\mathsf{CCR}}. \end{array}$ 



### 7.2 DC Voltage Characteristics

|                   |  |                              | 2.7 \                     | /-3.6 V                     | 2.7 V-                     | 2.85 V                    | 2.7 V-                     | 3.3 V                     |      |   |
|-------------------|--|------------------------------|---------------------------|-----------------------------|----------------------------|---------------------------|----------------------------|---------------------------|------|---|
| Symbol Parameter  |  | V <sub>CCQ</sub> 2.7 V-3.6 V |                           | /-3.6 V                     | 1.65 V                     | –2.5 V                    | 1.8 V–                     | 2.5 V                     | Unit | Test Conditions   |
|                   |  | Note                         | Min                       | Max                         | Min                        | Max                       | Min                        | Max                       |      |   |
| V <sub>IL</sub>   | Input Low<br>Voltage                               |                              | -0.4                      | V <sub>CC</sub> *<br>0.22 V | -0.4                       | 0.4                       | -0.4                       | 0.4                       | V    |   |
| V <sub>IH</sub>   | Input High<br>Voltage                              |                              | 2.0                       | V <sub>CCQ</sub><br>+0.3V   | V <sub>CCQ</sub> -<br>0.4V | V <sub>CCQ</sub><br>+0.3V | V <sub>CCQ</sub> -<br>0.4V | V <sub>CCQ</sub><br>+0.3V | V    |   |
| V <sub>OL</sub>   | Output Low<br>Voltage                              |                              | -0.1                      | 0.1                         | -0.1                       | 0.1                       | -0.1                       | 0.1                       | v    | $V_{CC} = V_{CC}Min$ $V_{CCQ} = V_{CCQ}Min$ $I_{OL} = 100 \ \mu A$        |
| V <sub>OH</sub>   | Output High<br>Voltage                             |                              | V <sub>CCQ</sub><br>-0.1V |                             | V <sub>CCQ</sub> -<br>0.1V |                           | V <sub>CCQ</sub> -<br>0.1V |                           | v    | $V_{CC} = V_{CC}Min$<br>$V_{CCQ} = V_{CCQ}Min$<br>$I_{OH} = -100 \ \mu A$ |
| V <sub>PPLK</sub> | V <sub>PP</sub> Lock-<br>Out Voltage               | 1                            |                           | 1.0                         |                            | 1.0                       |                            | 1.0                       | V    | Complete Write<br>Protection  |
| V <sub>PP1</sub>  | V <sub>PP</sub> During                             | 1                            | 1.65                      | 3.6                         | 1.65                       | 3.6                       | 1.65                       | 3.6                       | V    |   |
| V <sub>PP2</sub>  | Program /<br>Erase<br>Operations                   | 1,2                          | 11.4                      | 12.6                        | 11.4                       | 12.6                      | 11.4                       | 12.6                      | V    |   |
| V <sub>LKO</sub>  | V <sub>CC</sub> Prog/<br>Erase<br>Lock<br>Voltage  |                              | 1.5                       |                             | 1.5                        |                           | 1.5                        |                           | v    |   |
| V <sub>LKO2</sub> | V <sub>CCQ</sub> Prog/<br>Erase<br>Lock<br>Voltage |                              | 1.2                       |                             | 1.2                        |                           | 1.2                        |                           | v    |   |

#### Table 14. DC Voltage Characteristics

Notes:

Erase and Program are inhibited when V<sub>PP</sub> < V<sub>PPLK</sub> and not guaranteed outside the valid V<sub>PP</sub> ranges of V<sub>PP1</sub> and V<sub>PP2</sub>.
 V<sub>PP</sub> = 11.4 V–12.6 V can be applied during program/erase only for a maximum of 1000 cycles on the main blocks and 2500 cycles on the parameter blocks. V<sub>PP</sub> can be connected to 12 V for a total of 80 hours maximum.

#### **AC Characteristics** 8.0

#### 8.1 **AC Read Characteristics**

#### Table 15. **Read Operations—8-Mbit Density**

|     |                   |   | Den     | sity            |     |               |     | 8 N           | lbit   |         |               |     |      |
|-----|-------------------|---|---------|-----------------|-----|---------------|-----|---------------|--------|---------|---------------|-----|------|
|     |                   | Demonstra   | Pro     | duct            |     | 90            | ns  |               | 110 ns |         |               |     | Unit |
| #   | Sym               | Parameter   | V       | V <sub>cc</sub> |     | 3.0 V – 3.6 V |     | 2.7 V – 3.6 V |        | - 3.6 V | 2.7 V – 3.6 V |     | Unit |
|     |                   |   |         | Note            | Min | Max           | Min | Мах           | Min    | Max     | Min           | Max |      |
| R1  | t <sub>AVAV</sub> | Read Cycle Time   |         | 3,4             | 80  |               | 90  |               | 100    |         | 110           |     | ns   |
| R2  | t <sub>AVQV</sub> | Address to Outpu  | t Delay | 3,4             |     | 80            |     | 90            |        | 100     |               | 110 | ns   |
| R3  | t <sub>ELQV</sub> | CE# to Output De  | lay     | 1,3,4           |     | 80            |     | 90            |        | 100     |               | 110 | ns   |
| R4  | t <sub>GLQV</sub> | OE# to Output De  | elay    | 1,3,4           |     | 30            |     | 30            |        | 30      |               | 30  | ns   |
| R5  | t <sub>PHQV</sub> | RP# to Output De  | lay     | 3,4             |     | 150           |     | 150           |        | 150     |               | 150 | ns   |
| R6  | t <sub>ELQX</sub> | CE# to Output in  | Low Z   | 2,3,4           | 0   |               | 0   |               | 0      |         | 0             |     | ns   |
| R7  | t <sub>GLQX</sub> | OE# to Output in  | Low Z   | 2,3,4           | 0   |               | 0   |               | 0      |         | 0             |     | ns   |
| R8  | t <sub>EHQZ</sub> | CE# to Output in  | High Z  | 2,3,4           |     | 20            |     | 20            |        | 20      |               | 20  | ns   |
| R9  | t <sub>GHQZ</sub> | OE# to Output in  | High Z  | 2,3,4           |     | 20            |     | 20            |        | 20      |               | 20  | ns   |
| R10 | t <sub>OH</sub>   | Output Hold from<br>Address, CE#, or<br>Change, Whichev<br>Occurs First | OE#     | 2,3,4           | 0   |               | 0   |               | 0      |         | 0             |     | ns   |

Notes:

1.

2.

3.

OE# can be delayed up to  $t_{ELQV}-t_{GLQV}$  after the falling edge of CE# without impact on  $t_{ELQV}$ . Sampled, but not 100% tested. See Figure 10 "Read Operation Waveform" on page 40. See Figure 12 "AC Input/Output Reference Waveform" on page 46 for timing measurements and maximum allowable 4. input slew rate.



|     |                   |                    | Density                                       |                |     |     |                |     | 16 N           | <b>//bit</b> |                |     |          |       |       |      |       |
|-----|-------------------|--------------------|---|----------------|-----|-----|----------------|-----|----------------|--------------|----------------|-----|----------|-------|-------|------|-------|
|     |                   | Param              | Product                                       | 70             | ns  | 80  | ns             |     | 90             | ns           |                |     | 110      | ) ns  |       |      |       |
| #   | Sym               | eter               | v <sub>cc</sub>                               | 2.7 V–3.6<br>V |     |     | 2.7 V–3.6<br>V |     | 3.0 V-3.6<br>V |              | 2.7 V–3.6<br>V |     | V–<br>6V | 2.7 V | -3.6V | Unit | Notes |
|     |                   |                    |   | Min            | Max | Min | Max            | Min | Max            | Min          | Max            | Min | Max      | Min   | Max   |      |       |
| R1  | t <sub>AVAV</sub> | Read Cy            | ycle Time                                     | 70             |     | 80  |                | 80  |                | 90           |                | 100 |          | 110   |       | ns   | 3,4   |
| R2  | t <sub>AVQV</sub> | Address<br>Delay   | to Output                                     |                | 70  |     | 80             |     | 80             |              | 90             |     | 100      |       | 110   | ns   | 3,4   |
| R3  | t <sub>ELQV</sub> | CE# to 0<br>Delay  | Output  |                | 70  |     | 80             |     | 80             |              | 90             |     | 100      |       | 110   | ns   | 1,3,4 |
| R4  | t <sub>GLQV</sub> | OE# to 0<br>Delay  | Output  |                | 20  |     | 20             |     | 30             |              | 30             |     | 30       |       | 30    | ns   | 1,3,4 |
| R5  | t <sub>PHQV</sub> | RP# to 0<br>Delay  | Dutput  |                | 150 |     | 150            |     | 150            |              | 150            |     | 150      |       | 150   | ns   | 3,4   |
| R6  | t <sub>ELQX</sub> | CE# to C<br>Low Z  | Output in                                     | 0              |     | 0   |                | 0   |                | 0            |                | 0   |          | 0     |       | ns   | 2,3,4 |
| R7  | t <sub>GLQX</sub> | OE# to 0<br>Low Z  | Output in                                     | 0              |     | 0   |                | 0   |                | 0            |                | 0   |          | 0     |       | ns   | 2,3,4 |
| R8  | t <sub>EHQZ</sub> | CE# to C<br>High Z | Output in                                     |                | 20  |     | 20             |     | 20             |              | 20             |     | 20       |       | 20    | ns   | 2,3,4 |
| R9  | t <sub>GHQZ</sub> | OE# to (<br>High Z | Output in                                     |                | 20  |     | 20             |     | 20             |              | 20             |     | 20       |       | 20    | ns   | 2,3,4 |
| R10 | t <sub>OH</sub>   | Address<br>OE# Ch  | Hold from<br>, CE#, or<br>ange,<br>/er Occurs | 0              |     | 0   |                | 0   |                | 0            |                | 0   |          | 0     |       | ns   | 2,3,4 |

#### Table 16. **Read Operations—16-Mbit Density**

Notes:

1.

2. 3.

OE# can be delayed up to  $t_{ELQV}-t_{GLQV}$  after the falling edge of CE# without impact on  $t_{ELQV}$ . Sampled, but not 100% tested. See Figure 10 "Read Operation Waveform" on page 40. See Figure 12 "AC Input/Output Reference Waveform" on page 46 for timing measurements and maximum allowable 4. input slew rate.

|     |                   |                    | Density         |     |            |     |            |     | 32         | Mbit |            |     |            |     |            |      |       |
|-----|-------------------|--------------------|-----------------|-----|------------|-----|------------|-----|------------|------|------------|-----|------------|-----|------------|------|-------|
|     |                   | Param              | Product         | 70  | ns         | 90  | ns         |     | 100        | ) ns |            |     | 110        | ns  |            |      |       |
| #   | Sym               | eter               | v <sub>cc</sub> |     | /-3.6<br>V |     | /-3.6<br>V |     | /-3.3<br>V |      | /-3.3<br>V |     | /-3.3<br>/ |     | /-3.3<br>V | Unit | Notes |
|     |                   |                    |                 | Min | Max        | Min | Max        | Min | Max        | Min  | Max        | Min | Max        | Min | Max        |      |       |
| R1  | t <sub>AVAV</sub> | Read Cy            | /cle Time       | 70  |            | 90  |            | 90  |            | 100  |            | 100 |            | 110 |            | ns   | 3,4   |
| R2  | t <sub>AVQV</sub> | Address<br>Delay   | to Output       |     | 70         |     | 90         |     | 90         |      | 100        |     | 100        |     | 110        | ns   | 3,4   |
| R3  | t <sub>ELQV</sub> | CE# to C<br>Delay  | Dutput          |     | 70         |     | 90         |     | 90         |      | 100        |     | 100        |     | 110        | ns   | 1,3,4 |
| R4  | t <sub>GLQV</sub> | OE# to 0<br>Delay  | Dutput          |     | 20         |     | 20         |     | 30         |      | 30         |     | 30         |     | 30         | ns   | 1,3,4 |
| R5  | t <sub>PHQV</sub> | RP# to 0<br>Delay  | Dutput          |     | 150        |     | 150        |     | 150        |      | 150        |     | 150        |     | 150        | ns   | 3,4   |
| R6  | t <sub>ELQX</sub> | CE# to C<br>Low Z  | Dutput in       | 0   |            | 0   |            | 0   |            | 0    |            | 0   |            | 0   |            | ns   | 2,3,4 |
| R7  | t <sub>GLQX</sub> | OE# to 0<br>Low Z  | Dutput in       | 0   |            | 0   |            | 0   |            | 0    |            | 0   |            | 0   |            | ns   | 2,3,4 |
| R8  | t <sub>EHQZ</sub> | CE# to C<br>High Z | Dutput in       |     | 20         |     | 20         |     | 20         |      | 20         |     | 20         |     | 20         | ns   | 2,3,4 |
| R9  | t <sub>GHQZ</sub> | OE# to 0<br>High Z | Output in       |     | 20         |     | 20         |     | 20         |      | 20         |     | 20         |     | 20         | ns   | 2,3,4 |
| R10 | t <sub>ОН</sub>   |                    | /er             | 0   |            | 0   |            | 0   |            | 0    |            | 0   |            | 0   |            | ns   | 2,3,4 |

Table 17. Read Operations—32-Mbit Density

Notes:

1.

2.

3.

OE# can be delayed up to  $t_{ELQV}-t_{GLQV}$  after the falling edge of CE# without impact on  $t_{ELQV}$ . Sampled, but not 100% tested. See Figure 10 "Read Operation Waveform" on page 40. See Figure 12 "AC Input/Output Reference Waveform" on page 46 for timing measurements and maximum 4. allowable input slew rate.

#### Table 18. **Read Operations — 64-Mbit Density**

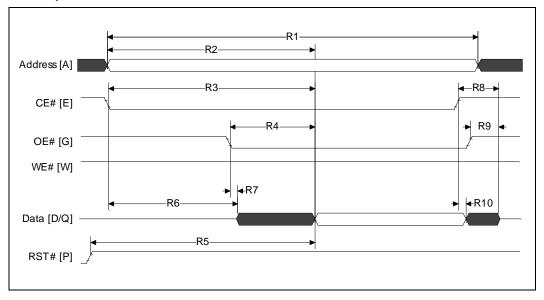
|     |                   |   | Densi           | ty    |        | 64 I   | Nbit   |      |      |
|-----|-------------------|---|-----------------|-------|--------|--------|--------|------|------|
| #   | 0                 | Demonster   | Produ           | ct    | 70     | ns     | 80     | ns   | Unit |
| #   | Sym               | Parameter   | V <sub>cc</sub> |       | 2.7 V- | -3.6 V | 2.7 V- | Unit |      |
|     |                   |   |                 | Note  | Min    | Max    | Min    | Max  |      |
| R1  | t <sub>AVAV</sub> | Read Cycle Time   |                 | 3,4   | 70     |        | 80     |      | ns   |
| R2  | t <sub>AVQV</sub> | Address to Output Delay                                 |                 | 3,4   |        | 70     |        | 80   | ns   |
| R3  | t <sub>ELQV</sub> | CE# to Output Delay                                     |                 | 1,3,4 |        | 70     |        | 80   | ns   |
| R4  | t <sub>GLQV</sub> | OE# to Output Delay                                     |                 | 1,3,4 |        | 20     |        | 20   | ns   |
| R5  | t <sub>PHQV</sub> | RP# to Output Delay                                     |                 | 3,4   |        | 150    |        | 150  | ns   |
| R6  | t <sub>ELQX</sub> | CE# to Output in Low Z                                  |                 | 2,3,4 | 0      |        | 0      |      | ns   |
| R7  | t <sub>GLQX</sub> | OE# to Output in Low Z                                  |                 | 2,3,4 | 0      |        | 0      |      | ns   |
| R8  | t <sub>EHQZ</sub> | CE# to Output in High Z                                 |                 | 2,3,4 |        | 20     |        | 20   | ns   |
| R9  | t <sub>GHQZ</sub> | OE# to Output in High Z                                 |                 | 2,3,4 |        | 20     |        | 20   | ns   |
| R10 | t <sub>OH</sub>   | Output Hold from Address, C<br>Change, Whichever Occurs |                 | 2,3,4 | 0      |        | 0      |      | ns   |

#### Notes:

OE# can be delayed up to  $t_{ELQV}$ - $t_{GLQV}$  after the falling edge of CE# without impact on  $t_{ELQV}$ . Sampled, but not 100% tested. See Figure 10 "Read Operation Waveform" on page 40. See Figure 12 "AC Input/Output Reference Waveform" on page 46 for timing measurements and 1.

2. 3.

4. maximum allowable input slew rate.



#### Figure 10. **Read Operation Waveform**

#### 8.2 **AC Write Characteristics**

|     |  |                                     |  | Density       |       |     | 8 N | lbit |     |      |
|-----|--|-------------------------------------|--|---------------|-------|-----|-----|------|-----|------|
|     |  |                                     |  | Product       |       | 90  | ns  | 110  | ns  |      |
| #   | Sym                                      | Parameter                           | M                                      | 3.0 V –       | 3.6 V | 80  |     | 100  |     | Unit |
|     |  |                                     | V <sub>CC</sub>                        | 2.7 V – 3.6 V |       |     | 90  |      | 110 |      |
|     |  |                                     |  |               | Note  | Min | Min | Min  | Min |      |
| W1  | t <sub>PHWL</sub> /<br>t <sub>PHEL</sub> | RP# High Recovery to V              | VE# (CE#)                              | Going Low     | 4,5   | 150 | 150 | 150  | 150 | ns   |
| W2  | t <sub>ELWL</sub> /<br>t <sub>WLEL</sub> | CE# (WE#) Setup to WE               | CE# (WE#) Setup to WE# (CE#) Going Low |               |       | 0   | 0   | 0    | 0   | ns   |
| W3  | t <sub>WLWH</sub> /<br>t <sub>ELEH</sub> | WE# (CE#) Pulse Width               |  |               |       | 50  | 60  | 70   | 70  | ns   |
| W4  | t <sub>DVWH</sub> /<br>t <sub>DVEH</sub> | Data Setup to WE# (CE               | #) Going H                             | igh           | 2,4,5 | 50  | 50  | 60   | 60  | ns   |
| W5  | t <sub>AVWH</sub> /<br>t <sub>AVEH</sub> | Address Setup to WE#                | Address Setup to WE# (CE#) Going High  |               |       | 50  | 60  | 70   | 70  | ns   |
| W6  | t <sub>WHEH</sub> /<br>t <sub>EHWH</sub> | CE# (WE#) Hold Time fi              | rom WE# (0                             | CE#) High     | 4,5   | 0   | 0   | 0    | 0   | ns   |
| W7  | t <sub>WHDX</sub> /<br>t <sub>EHDX</sub> | Data Hold Time from W               | E# (CE#) H                             | igh           | 2,4,5 | 0   | 0   | 0    | 0   | ns   |
| W8  | t <sub>WHAX</sub> /<br>t <sub>EHAX</sub> | Address Hold Time from              | n WE# (CE#                             | ¢) High       | 2,4,5 | 0   | 0   | 0    | 0   | ns   |
| W9  | t <sub>WHWL /</sub><br>t <sub>EHEL</sub> | WE# (CE#) Pulse Width               | ı High                                 |               | 2,4,5 | 30  | 30  | 30   | 30  | ns   |
| W10 | t <sub>VPWH</sub> /<br>t <sub>VPEH</sub> | V <sub>PP</sub> Setup to WE# (CE#   | ŧ) Going Hi                            | gh            | 3,4,5 | 200 | 200 | 200  | 200 | ns   |
| W11 | t <sub>QVVL</sub>                        | V <sub>PP</sub> Hold from Valid SRI | D                                      |               | 3,4   | 0   | 0   | 0    | 0   | ns   |
| W12 | t <sub>BHWH</sub> /<br>t <sub>BHEH</sub> | WP# Setup to WE# (CE                | P# Setup to WE# (CE#) Going High       |               |       | 0   | 0   | 0    | 0   | ns   |
| W13 | t <sub>QVBL</sub>                        | WP# Hold from Valid SRD             |  |               | 3,4   | 0   | 0   | 0    | 0   | ns   |
| W14 | t <sub>WHGL</sub>                        | WE# High to OE# Going               | WE# High to OE# Going Low              |               | 3,4   | 30  | 30  | 30   | 30  | ns   |

Notes:

Write pulse width (t<sub>WP</sub>) is defined from CE# or WE# going low (whichever goes low last) to CE# or WE# going high 1. (whichever goes high first). So  $t_{WP} = t_{WLWH} = t_{ELEH} = t_{WLEH} = t_{ELWH}$ .

Similarly, write pulse width high ( $t_{WPH}$ ) is defined from CE# or WE# going high (whichever goes high first) to CE# or WE# going low (whichever goes low last). So  $t_{WPH} = t_{WHWL} = t_{EHEL} = t_{WHEL} = t_{EHWL}$ . Refer to Table 27 "Bus Operations<sup>(1)</sup>" on page 51 for valid A<sub>IN</sub> or D<sub>IN</sub>.

2.

3. Sampled, but not 100% tested.

See Figure 12 "AC Input/Output Reference Waveform" on page 46 for timing measurements and maximum allowable 4. input slew rate.

5. See Figure 11 "Write Operations Waveform" on page 45.



|     |  |                            |                                      | Density       |       |       |       | 16 M | bit |     |      |      |
|-----|--|----------------------------|--------------------------------------|---------------|-------|-------|-------|------|-----|-----|------|------|
|     |  |                            |                                      | Product       |       | 70 ns | 80 ns | 90   | ns  | 110 | ) ns | -    |
| #   | Sym                                      | Parameter                  | v                                    | 3.0 V - 3.0   | 6 V   |       |       | 80   |     | 100 |      | Unit |
|     |  |                            | V <sub>cc</sub>                      | 2.7 V - 3.0   | 6 V   | 70    | 80    |      | 90  |     | 110  | -    |
|     |  |                            |                                      |               | Note  | Min   | Min   | Min  | Min | Min | Min  | -    |
| W1  | t <sub>PHWL</sub> /<br>t <sub>PHEL</sub> | RP# High Reco<br>Low       | overy to WE# (                       | (CE#) Going   | 4,5   | 150   | 150   | 150  | 150 | 150 | 150  | ns   |
| W2  | t <sub>ELWL</sub> /<br>t <sub>WLEL</sub> | CE# (WE#) Set              | tup to WE# (C                        | E#) Going Low | 4,5   | 0     | 0     | 0    | 0   | 0   | 0    | ns   |
| W3  | t <sub>WLWH</sub> /<br>t <sub>ELEH</sub> | WE# (CE#) Pul              | # (CE#) Pulse Width                  |               | 1,4,5 | 45    | 50    | 50   | 60  | 70  | 70   | ns   |
| W4  | t <sub>DVWH</sub> /<br>t <sub>DVEH</sub> | Data Setup to V            | ta Setup to WE# (CE#) Going High     |               | 2,4,5 | 40    | 40    | 50   | 50  | 60  | 60   | ns   |
| W5  | t <sub>AVWH</sub> /<br>t <sub>AVEH</sub> | Address Setup              | ddress Setup to WE# (CE#) Going High |               | 2,4,5 | 50    | 50    | 50   | 60  | 70  | 70   | ns   |
| W6  | t <sub>WHEH</sub> /<br>t <sub>EHWH</sub> | CE# (WE#) Ho<br>High       | ld Time from V                       | VE# (CE#)     | 4,5   | 0     | 0     | 0    | 0   | 0   | 0    | ns   |
| W7  | t <sub>WHDX</sub> /<br>t <sub>EHDX</sub> | Data Hold Time             | e from WE# (C                        | E#) High      | 2,4,5 | 0     | 0     | 0    | 0   | 0   | 0    | ns   |
| W8  | t <sub>WHAX</sub> /<br>t <sub>EHAX</sub> | Address Hold T             | ime from WE                          | # (CE#) High  | 2,4,5 | 0     | 0     | 0    | 0   | 0   | 0    | ns   |
| W9  | t <sub>WHWL</sub> /<br>t <sub>EHEL</sub> | WE# (CE#) Pul              | se Width High                        | 1             | 1,4,5 | 25    | 30    | 30   | 30  | 30  | 30   | ns   |
| W10 | t <sub>VPWH</sub> /<br>t <sub>VPEH</sub> | V <sub>PP</sub> Setup to W | /E# (CE#) Goi                        | ing High      | 3,4,5 | 200   | 200   | 200  | 200 | 200 | 200  | ns   |
| W11 | t <sub>QVVL</sub>                        | V <sub>PP</sub> Hold from  | Valid SRD                            |               | 3,4   | 0     | 0     | 0    | 0   | 0   | 0    | ns   |
| W12 | t <sub>внwн</sub> /<br>t <sub>внен</sub> | WP# Setup to V             | NE# (CE#) Go                         | bing High     | 3,4   | 0     | 0     | 0    | 0   | 0   | 0    | ns   |
| W13 | t <sub>QVBL</sub>                        | WP# Hold from              | Valid SRD                            |               | 3,4   | 0     | 0     | 0    | 0   | 0   | 0    | ns   |
| W14 | t <sub>WHGL</sub>                        | WE# High to O              | h to OE# Going Low                   |               |       | 30    | 30    | 30   | 30  | 30  | 30   | ns   |

#### Table 20. Write Operations—16-Mbit Density

Notes:

Write pulse width (t<sub>WP</sub>) is defined from CE# or WE# going low (whichever goes low last) to CE# or WE# going high 1. (whichever goes high first). So  $t_{WP} = t_{WLWH} = t_{ELEH} = t_{WLEH} = t_{ELWH}$ .

Similarly, write pulse width high ( $t_{WPH}$ ) is defined from CE# or WE# going high (whichever goes high first) to CE# or WE# going low (whichever goes low last). So  $t_{WPH} = t_{WHWL} = t_{EHEL} = t_{WHEL} = t_{EHWL}$ . Refer to Table 27 "Bus Operations<sup>(1)</sup>" on page 51 for valid A<sub>IN</sub> or D<sub>IN</sub>.

2.

3. 4.

Sampled, but not 100% tested. See Figure 12 "AC Input/Output Reference Waveform" on page 46 for timing measurements and maximum allowable input slew rate.

5. See Figure 11 "Write Operations Waveform" on page 45.

|     |   |                                    |                           | Densit  | y                    | 32 Mbit |       |     |     |     |     |      |
|-----|---|------------------------------------|---------------------------|---------|----------------------|---------|-------|-----|-----|-----|-----|------|
|     |   |                                    |                           | Produ   | ct                   | 70 ns   | 90 ns | 100 | ns  | 110 | ns  |      |
| #   | Sym   | Parameter                          |                           | 3.0 V   | – 3.6 V <sup>6</sup> |         |       | 90  |     | 100 |     | Unit |
|     |   |                                    | V <sub>cc</sub>           | 2.7 V   | – 3.6 V              | 70      | 90    |     | 100 |     | 110 |      |
|     |   |                                    |                           |         | Note                 | Min     | Min   | Min | Min | Min | Min |      |
| W1  | t <sub>PHWL</sub> /<br>t <sub>PHEL</sub>    | RP# High Recovery to<br>Going Low  | WE# (C                    | E#)     | 4,5                  | 150     | 150   | 150 | 150 | 150 | 150 | ns   |
| W2  | t <sub>ELWL</sub> /<br>t <sub>WLEL</sub>    | CE# (WE#) Setup to W<br>Going Low  | E# (CE                    | #)      | 4,5                  | 0       | 0     | 0   | 0   | 0   | 0   | ns   |
| W3  | t <sub>WLWH</sub><br>/<br>t <sub>ELEH</sub> | WE# (CE#) Pulse Widtl              | า                         |         | 1,4,5                | 45      | 60    | 60  | 70  | 70  | 70  | ns   |
| W4  | t <sub>DVWH</sub> /<br>t <sub>DVEH</sub>    | Data Setup to WE# (CE              | #) Goir                   | ng High | 2,4,5                | 40      | 40    | 50  | 60  | 60  | 60  | ns   |
| W5  | t <sub>AVWH</sub> /<br>t <sub>AVEH</sub>    | Address Setup to WE#<br>High       | (CE#) (                   | Going   | 2,4,5                | 50      | 60    | 60  | 70  | 70  | 70  | ns   |
| W6  | t <sub>WHEH</sub> /<br>t <sub>EHWH</sub>    | CE# (WE#) Hold Time<br>(CE#) High  | from W                    | E#      | 4,5                  | 0       | 0     | 0   | 0   | 0   | 0   | ns   |
| W7  | t <sub>WHDX</sub> /<br>t <sub>EHDX</sub>    | Data Hold Time from W<br>High      | 'E# (CE                   | #)      | 2,4,5                | 0       | 0     | 0   | 0   | 0   | 0   | ns   |
| W8  | t <sub>WHAX</sub> /<br>t <sub>EHAX</sub>    | Address Hold Time from<br>High     | n WE#                     | (CE#)   | 2,4,5                | 0       | 0     | 0   | 0   | 0   | 0   | ns   |
| W9  | t <sub>WHWL /</sub><br>t <sub>EHEL</sub>    | WE# (CE#) Pulse Widtl              | n High                    |         | 1,4,5                | 25      | 30    | 30  | 30  | 30  | 30  | ns   |
| W10 | t <sub>VPWH</sub> /<br>t <sub>VPEH</sub>    | V <sub>PP</sub> Setup to WE# (CE   | #) Goin                   | g High  | 3,4,5                | 200     | 200   | 200 | 200 | 200 | 200 | ns   |
| W11 | t <sub>QVVL</sub>                           | V <sub>PP</sub> Hold from Valid SR | D                         |         | 3,4                  | 0       | 0     | 0   | 0   | 0   | 0   | ns   |
| W12 | t <sub>BHWH</sub> /<br>t <sub>BHEH</sub>    | WP# Setup to WE# (CE<br>High       | E#) Goii                  | ng      | 3,4                  | 0       | 0     | 0   | 0   | 0   | 0   | ns   |
| W13 | t <sub>QVBL</sub>                           | WP# Hold from Valid S              | RD                        |         | 3,4                  | 0       | 0     | 0   | 0   | 0   | 0   | ns   |
| W14 | t <sub>WHGL</sub>                           | WE# High to OE# Goin               | /E# High to OE# Going Low |         | 3,4                  | 30      | 30    | 30  | 30  | 30  | 30  | ns   |

#### Table 21. Write Operations—32-Mbit Density

Notes:

Write pulse width ( $t_{WP}$ ) is defined from CE# or WE# going low (whichever goes low last) to CE# or WE# going high (whichever goes high first). So  $t_{WP} = t_{WLWH} = t_{ELEH} = t_{WLEH} = t_{ELWH}$ . 1.

Similarly, write pulse width high ( $t_{WPH}$ ) is defined from CE# or WE# going high (whichever goes high first) to CE# or WE# going low (whichever goes low last). So  $t_{WPH} = t_{WHWL} = t_{EHEL} = t_{WHEL} = t_{EHWL}$ . Refer to Table 27 "Bus Operations<sup>(1)</sup>" on page 51 for valid A<sub>IN</sub> or D<sub>IN</sub>. Sampled, but not 100% tested.

2.

3.

4. See Figure 12 "AC Input/Output Reference Waveform" on page 46 for timing measurements and maximum allowable input slew rate.

See Figure 11 "Write Operations Waveform" on page 45. 5.

6. V<sub>CC</sub>Max = 3.3 V for 32-Mbit 0.25 Micron product.



|     |                                       |   |                     | Density       |       | 64 Mbit |      |
|-----|---------------------------------------|---|---------------------|---------------|-------|---------|------|
| #   | Symbol                                | Parameter                                     |                     | Product       |       | 80 ns   | Unit |
|     |                                       |   | V <sub>cc</sub>     | 2.7 V – 3.6 V | Note  | Min     |      |
| W1  | t <sub>PHWL</sub> / t <sub>PHEL</sub> | RP# High Recovery to WE# (CE#) Go             | ing Low             |               | 4,5   | 150     | ns   |
| W2  | t <sub>ELWL</sub> / t <sub>WLEL</sub> | CE# (WE#) Setup to WE# (CE#) Going            | g Low               |               | 4,5   | 0       | ns   |
| W3  | t <sub>WLWH</sub> / t <sub>ELEH</sub> | WE# (CE#) Pulse Width                         | 1,4,5               | 60            | ns    |         |      |
| W4  | t <sub>DVWH</sub> / t <sub>DVEH</sub> | Data Setup to WE# (CE#) Going High            | 2,4,5               | 40            | ns    |         |      |
| W5  | t <sub>AVWH</sub> / t <sub>AVEH</sub> | Address Setup to WE# (CE#) Going H            | 2,4,5               | 60            | ns    |         |      |
| W6  | t <sub>WHEH</sub> / t <sub>EHWH</sub> | CE# (WE#) Hold Time from WE# (CE#             | <sup>#</sup> ) High |               | 4,5   | 0       | ns   |
| W7  | t <sub>WHDX</sub> / t <sub>EHDX</sub> | Data Hold Time from WE# (CE#) High            |                     |               | 2,4,5 | 0       | ns   |
| W8  | t <sub>WHAX</sub> / t <sub>EHAX</sub> | Address Hold Time from WE# (CE#) H            | ligh                |               | 2,4,5 | 0       | ns   |
| W9  | t <sub>WHWL /</sub> t <sub>EHEL</sub> | WE# (CE#) Pulse Width High                    |                     |               | 1,4,5 | 30      | ns   |
| W10 | t <sub>VPWH</sub> / t <sub>VPEH</sub> | V <sub>PP</sub> Setup to WE# (CE#) Going High |                     |               | 3,4,5 | 200     | ns   |
| W11 | t <sub>QVVL</sub>                     | V <sub>PP</sub> Hold from Valid SRD           |                     | 3,4           | 0     | ns      |      |
| W12 | t <sub>BHWH</sub> / t <sub>BHEH</sub> | WP# Setup to WE# (CE#) Going High             |                     | 3,4           | 0     | ns      |      |
| W13 | t <sub>QVBL</sub>                     | WP# Hold from Valid SRD                       |                     | 3,4           | 0     | ns      |      |
| W14 | t <sub>WHGL</sub>                     | WE# High to OE# Going Low                     |                     | 3,4           | 30    | ns      |      |

#### Write Operations—64-Mbit Density Table 22.

Notes:

2.

Write pulse width ( $t_{WP}$ ) is defined from CE# or WE# going low (whichever goes low last) to CE# or WE# going high (whichever goes high first). So  $t_{WP} = t_{WLWH} = t_{ELEH} = t_{WLEH} = t_{ELWH}$ . 1.

Similarly, write pulse width high ( $t_{WPH}$ ) is defined from CE# or WE# going high (whichever goes high first) to CE# or WE# going low (whichever goes low last). So  $t_{WPH} = t_{WHWL} = t_{EHEL} = t_{WHEL} = t_{EHWL}$ . Refer to Table 27 "Bus Operations<sup>(1)</sup>" on page 51 for valid A<sub>IN</sub> or D<sub>IN</sub>.

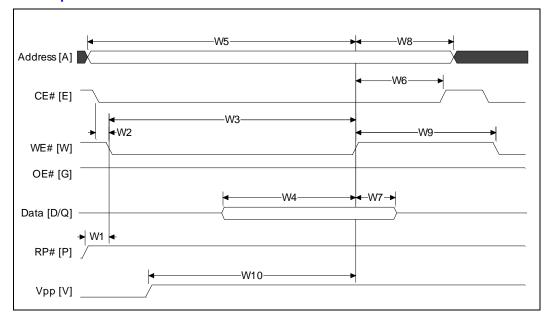
3. Sampled, but not 100% tested.

4. See Figure 12 "AC Input/Output Reference Waveform" on page 46 for timing measurements and maximum allowable input slew rate.

5. See Figure 11 "Write Operations Waveform" on page 45.

# inte

Figure 11. Write Operations Waveform



#### 8.3 **Erase and Program Timing**

#### Table 23. **Erase and Program Timing**

| Symbol                                  | Parameter   | V <sub>PP</sub> | 1.65 V | –3.6 V | 11.4 V-  | -12.6 V | Unit |
|---|---|-----------------|--------|--------|--|---------|------|
| Symbol                                  | Falameter   | Note            | Тур    | Max    | 0.30     0.03       2.4     0.24       200     8       200     8       4     0.4 | Max     | Unit |
| t <sub>BWPB</sub>                       | 4-KW Parameter Block<br>Word Program Time             | 1, 2, 3         | 0.10   | 0.30   | 0.03   | 0.12    | s    |
| t <sub>BWMB</sub>                       | 32-KW Main Block<br>Word Program Time                 | 1, 2, 3         | 0.8    | 2.4    | 0.24   | 1       | s    |
| t                                       | Word Program Time for 0.13<br>and 0.18 Micron Product | 1, 2, 3         | 12     | 200    | 8  | 185     | μs   |
| t <sub>WHQV1</sub> / t <sub>EHQV1</sub> | Word Program Time for 0.25<br>Micron Product          | 1, 2, 3         | 22     | 200    | 8  | 185     | μs   |
| t <sub>WHQV2</sub> / t <sub>EHQV2</sub> | 4-KW Parameter Block<br>Erase Time                    | 1, 2, 3         | 0.5    | 4      | 0.4  | 4       | s    |
| t <sub>WHQV3</sub> / t <sub>EHQV3</sub> | 32-KW Main Block<br>Erase Time                        | 1, 2, 3         | 1      | 5      | 0.6  | 5       | s    |
| t <sub>WHRH1</sub> / t <sub>EHRH1</sub> | Program Suspend Latency                               | 1,3             | 5      | 10     | 5  | 10      | μs   |
| t <sub>WHRH2</sub> / t <sub>EHRH2</sub> | Erase Suspend Latency                                 | 1,3             | 5      | 20     | 5  | 20      | μs   |

Notes:

Typical values measured at  $T_A$ = +25 °C and nominal voltages. Excludes external system-level overhead. 1.

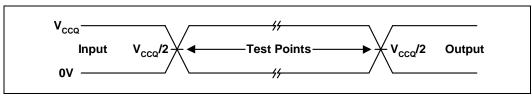
2.

3. Sampled, but not 100% tested.



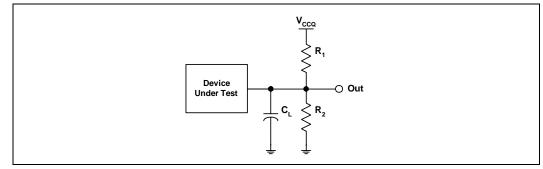
## 8.4 AC I/O Test Conditions

### Figure 12. AC Input/Output Reference Waveform



**Note:** Input timing begins, and output timing ends, at  $V_{CCQ}/2$ . Input rise and fall times (10% to 90%) < 5 ns. Worst-case speed conditions are when  $V_{CC} = V_{CC}$ Min.

### Figure 13. Transient Equivalent Testing Load Circuit



*Note:* See Table 24 for component values.

### Table 24. Test Configuration Component Values for Worst Case Speed Conditions

| Test Configuration                 | C <sub>L</sub> (pF) | <b>R<sub>1</sub> (k</b> Ω) | R <sub>2</sub> (kΩ) |
|------------------------------------|---------------------|----------------------------|---------------------|
| V <sub>CCQ</sub> Min Standard Test | 50                  | 25                         | 25                  |

*Note:* C<sub>L</sub> includes jig capacitance.

## 8.5 Device Capacitance

 $T_A = 25 \ ^\circ C, f = 1 \ MHz$ 

### Table 25.Device Capacitance

| Symbol           | Parameter§         | Тур | Max | Unit | Condition                |
|------------------|--------------------|-----|-----|------|--------------------------|
| C <sub>IN</sub>  | Input Capacitance  | 6   | 8   | pF   | V <sub>IN</sub> = 0.0 V  |
| C <sub>OUT</sub> | Output Capacitance | 8   | 12  | pF   | V <sub>OUT</sub> = 0.0 V |

<sup>§</sup>Sampled, not 100% tested.

# 9.0 **Power and Reset Specifications**

# 9.1 **Power-Up/Down Characteristics**

To prevent any condition that might result in a spurious write or erase operation, power-up  $V_{CC}$  and  $V_{CCO}$  together. Conversely,  $V_{CC}$  and  $V_{CCO}$  must power-down together.

Also power-up  $V_{PP}$  with or slightly after  $V_{CC}$ . Conversely,  $V_{PP}$  must power-down with or slightly before  $V_{CC}$ .

If  $V_{CCQ}$  and/or VPP are not connected to the  $V_{CC}$  supply, then  $V_{CC}$  must attain  $V_{CC}$ Min before applying VCCQ and VPP. Device inputs must not be driven before supply voltage = VCCMin. Power supply transitions must occur only when RP# is low.

## 9.1.1 RP# Connected to System Reset

Use RP# during system reset with automated program/erase devices, because the system expects to read from the flash memory when the system exits reset. If a CPU reset occurs without a flash memory reset, proper CPU initialization does not occur, because the flash memory might be providing status information instead of array data. Connecting RP# to the system CPU RESET# signal to allow proper CPU/flash initialization after a system reset.

System designers must guard against spurious writes when  $V_{CC}$  voltages are above  $V_{LKO}$ . Because both WE# and CE# must be low for a command write, driving either signal to  $V_{IH}$  inhibits writes to the flash memory device. The CUI architecture provides additional protection, because memory contents can be altered only after successful completion of the two-step command sequences. The flash memory device is also disabled until RP# is brought to  $V_{IH}$ , regardless of the state of its control inputs. By holding the device in reset (RP# connected to system POWERGOOD) during power-up/down, invalid bus conditions during power-up can be masked, providing yet another level of memory protection.

## 9.1.2 V<sub>CC</sub>, V<sub>PP</sub> and RP# Transitions

The CUI latches commands as issued by system software, and is not altered by  $V_{PP}$  or CE# transitions or WSM actions. The CUI default state upon power-up, after exit from reset mode or after  $V_{CC}$  transitions above  $V_{LKO}$  (Lockout voltage), is read-array mode.

After any program or Block-Erase operation is complete (even after  $V_{PP}$  transitions down to  $V_{PPLK}$ ), the CUI must be reset to read-array mode, using the Read Array command if access to the flash-memory array is required.



#### **Reset Specifications** 9.2

#### Table 26. **Reset Specifications**

| Symbol             | Parameter   | V <sub>CC</sub> 2.7 | V – 3.6 V | Unit | Notes |  |
|--------------------|---|---------------------|-----------|------|-------|--|
| Symbol             | rarameter   | Min                 | Мах       | Unit | Notes |  |
| t <sub>PLPH</sub>  | RP# Low to Reset during Read<br>(If RP# is tied to V <sub>CC</sub> , this specification is not<br>applicable) | 100                 |           | ns   | 1, 2  |  |
| t <sub>PLRH1</sub> | RP# Low to Reset during Block Erase   |                     | 22        | μs   | 3     |  |
| t <sub>PLRH2</sub> | RP# Low to Reset during Program   |                     | 12        | μs   | 3     |  |

Notes:

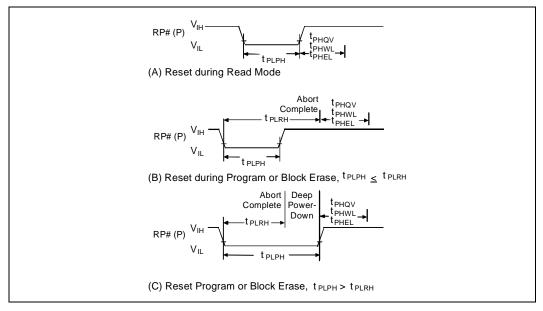
1. 2.

If  $t_{PLPH}$  is < 100 ns, the device can still reset, but reset is not guaranteed. If RP# is asserted while a Block Erase or Word Program operation is not executing, the

reset completes within 100 ns.

3. Sampled, but not 100% tested.

#### Figure 14. **Deep Power-Down/Reset Operations Waveforms**



# 9.3 Power Supply Decoupling

Flash memory power-switching characteristics require careful device decoupling. System designers must consider the following three supply current issues:

- 1. Standby current levels (I<sub>CCS</sub>).
- 2. Read current levels (I<sub>CCR</sub>).
- 3. Transient peaks produced by falling and rising edges of CE#.

Transient current magnitudes depend on the device output capacitive and inductive loading. Two-line control and proper decoupling capacitor selection suppresses these transient voltage peaks. Each flash device must have a 0.1  $\mu F$  ceramic capacitor connected between each  $V_{CC}$  and GND, and between its  $V_{PP}$  and GND. These high-frequency, inherently low-inductance capacitors must be placed as close as possible to the package leads.

# 9.4 **Power Consumption**

Intel<sup>®</sup> flash memory devices use a tiered approach to power savings that can significantly reduce overall system power consumption. The Automatic Power Savings (APS) feature reduces power consumption when the flash memory device is selected but idle. If CE# is deasserted, the flash memory device enters its standby mode, where current consumption is even lower. The combination of these features can minimize memory power consumption, and therefore minimize overall system power consumption.

## 9.4.1 Active Power

When CE# is at a logic-low level and RP# is at a logic-high level, the flash memory device is in the active mode. Refer to the DC Characteristic tables for  $I_{CC}$  current values. Active power is the largest contributor to overall system power consumption. Minimizing the active current can profoundly affect system power consumption, especially for battery-operated devices.

## 9.4.2 Automatic Power Savings (APS)

Automatic Power Savings provides low-power operation during read mode. After data is read from the flash memory array and the address lines are quiescent, APS circuitry places the flash memory device in a mode where typical current is comparable to I<sub>CCS</sub>. The flash memory stays in this static state with outputs valid until a new location is read.

## 9.4.3 Standby Power

When CE# is at a logic-high level ( $V_{IH}$ ) and the flash memory device is in read mode, the flash memory is in standby mode. This mode disables much of the device circuitry, and substantially reduces power consumption. Outputs are placed in a high-impedance state independent of the status of the OE# signal. If CE# transitions to a logic-high level during Erase or Program operations, the flash memory device continues to perform the operation and consume corresponding active power until the operation is completed.

System engineers must analyze the breakdown of standby time versus active time and quantify the respective power consumption in each mode for their specific application. This approach provides a more accurate measure of application-specific power and energy requirements.

Datasheet

Intel<sup>®</sup> Advanced Boot Block Flash Memory (B3) Order Number: 290580, Revision: 020



## 9.4.4 Deep Power-Down Mode

The deep power-down mode is activated when  $RP\# = V_{IL}$  (GND ± 0.2 V). During read modes, RP# going low deselects the flash memory and places the outputs in a high-impedance state. Recovery from deep power-down mode requires a minimum time of  $t_{PHQV}$  (see "AC Read Characteristics" on page 37).

During program or erase modes, RP# transitioning low aborts the in-progress operation. The memory contents of the address being programmed or the block being erased are no longer valid, because the abort compromises data integrity. During deep power-down, all internal circuits switch to a low-power savings mode (RP# transitioning to  $V_{IL}$  or turning off power to the flash memory device clears the Status Register).

# **10.0** Operations Overview

Flash memory combines EEPROM functionality with in-circuit electrical program-and-erase capability. The B3 flash memory device family uses a Command User Interface (CUI) and automated algorithms to simplify Program and Erase operations. The CUI allows for 100% CMOS-level control inputs and fixed power supplies during erasure and programming.

When  $V_{PP} < V_{PPLK}$ , the flash memory device executes only the following commands successfully:

- Read Array
- Read Status Register
- Clear Status Register
- Read Identifier

The flash memory device provides standard EEPROM read, standby, and Output-Disable operations.

Manufacturer identification and device identification data can be accessed through the CUI.

All functions that alter memory contents (program and erase) are accessible through the CUI. The internal Write State Machine (WSM) completely automates Program and Erase operations, while the CUI signals the start of an operation and the Status Register reports status.

The CUI handles the WE# interface to the data and address latches, and system status requests during WSM operation.

#### 10.1 **Bus Operations**

The B3 flash memory device performs read, program, and erase in-system operations through the local CPU or microcontroller. All bus cycles to or from the flash memory conform to standard microcontroller bus cycles. Four control pins dictate the data flow in and out of the flash memory device:

- CE#
- OE#
- WE#
- RP#

Table 27 summarizes these bus operations.

#### Bus Operations<sup>(1)</sup> Table 27.

| Mode                                | Note   | RP#             | CE#             | OE#             | WE#             | DQ <sub>0-7</sub> | DQ <sub>8-15</sub> |
|-------------------------------------|--------|-----------------|-----------------|-----------------|-----------------|-------------------|--------------------|
| Read (Array, Status, or Identifier) | 2–4    | V <sub>IH</sub> | V <sub>IL</sub> | V <sub>IL</sub> | V <sub>IH</sub> | D <sub>OUT</sub>  | D <sub>OUT</sub>   |
| Output Disable                      | 2      | V <sub>IH</sub> | V <sub>IL</sub> | V <sub>IH</sub> | V <sub>IH</sub> | High Z            | High Z             |
| Standby                             | 2      | V <sub>IH</sub> | V <sub>IH</sub> | Х               | Х               | High Z            | High Z             |
| Reset                               | 2, 7   | V <sub>IL</sub> | Х               | Х               | Х               | High Z            | High Z             |
| Write                               | 2, 5–7 | V <sub>IH</sub> | V <sub>IL</sub> | V <sub>IH</sub> | V <sub>IL</sub> | D <sub>IN</sub>   | D <sub>IN</sub>    |

Notes:

8-bit devices use only DQ[0:7]. 1.

16-bit devices use DQ[0:15].

X must be VIL, VIH for control pins and addresses. 2.

3.

See *DC Characteristics* for V<sub>PPLK</sub>, V<sub>PP1</sub>, V<sub>PP2</sub>, V<sub>PP3</sub>, V<sub>PP4</sub> voltages. Manufacturer and device codes can also be accessed in read identifier mode ( $A_1$ – $A_{21}$  = 0). See Table 29. 4.

5.

6.

Refer to Table 30 for valid D<sub>IN</sub> during a Write operation. To program or erase the lockable blocks, hold WP# at V<sub>IH</sub>. RP# must be at GND  $\pm$  0.2 V to meet the maximum deep power-down current specified. 7.

#### 10.1.1 Read

The B3 flash memory device provides four read modes:

- read array
- · read identifier
- · read status
- read query

These modes are accessible independently of the  $V_{PP}$  voltage. Issue the appropriate Read Mode command to the CUI to enter the corresponding mode. Upon initial device power-up or after exit from reset, the flash memory device automatically defaults to read-array mode.

CE# and OE# must be driven active to obtain data at the outputs.

- CE# is the device selection control. When active, CE# enables the flash memory device.
- OE# is the data output control, and drives the selected memory data onto the I/O bus.

For all read modes, WE# and RP# must be at  $V_{IH}$ . Figure 10 on page 40 illustrates a read cycle.

Intel<sup>®</sup> Advanced Boot Block Flash Memory (B3) Order Number: 290580, Revision: 020



## 10.1.2 Output Disable

When OE# is at a logic-high level ( $V_{IH}$ ), the flash memory device outputs are disabled. Output pins are placed in a high-impedance state.

### 10.1.3 Standby

Deselecting the flash memory device by bringing CE# to a logic-high level ( $V_{IH}$ ) places the device in standby mode. Standby mode substantially reduces device power consumption, without any latency for subsequent read accesses. In standby mode, outputs are placed in a high-impedance state independent of OE#. If deselected during Program or Erase operation, the flash memory device continues to consume active power until the Program or Erase operation is complete.

### 10.1.4 Deep Power-Down / Reset

From read mode, RP# at  $V_{IL}$  for time  $t_{PLPH}$  does the following:

- Deselects the flash memory.
- Places output drivers in a high-impedance state.
- Turns off all internal circuits.
- After a return from reset, a time t<sub>PHOV</sub> is required until the initial read-access outputs are valid.
- After a return from reset, a delay (t<sub>PHWL</sub> or t<sub>PHEL</sub>) is required before a write can be initiated.

After this wake-up interval, normal operation is restored. The CUI resets to read-array mode, and the Status Register is set to 80H. Figure 14 "Deep Power-Down/Reset Operations Waveforms" on page 48 (A) illustrates this case.

If RP# is taken low for time t<sub>PLPH</sub> during a Program or Erase operation, the operation aborts. The memory contents at the aborted location (for a program) or block (for an erase) are no longer valid, because the data might be partially erased or written.

The abort process uses the following sequence:

- 1. When RP# goes low, the flash memory device shuts down the operation in progress, a process that takes time t<sub>PLRH</sub> to complete.
- 2. After this time t<sub>PLRH</sub>, the flash memory device either resets to read-array mode (if RP# has gone high during t<sub>PLRH</sub>, see Figure 14 "Deep Power-Down/Reset Operations Waveforms" on page 48 (B)), or enters reset mode (if RP# is still logic low after t<sub>PLRH</sub>, see Figure 14 "Deep Power-Down/Reset Operations Waveforms" on page 48 (C)).
- 3. In both cases, after returning from an aborted operation, the relevant time  $t_{PHQV}$  or  $t_{PHWL}/t_{PHEL}$  must elapse before initiating a Read or Write operation, as discussed in the previous paragraph. However, in this case, these delays are referenced to the end of  $t_{PLRH}$  rather than when RP# goes high.

As with any automated device, RP# must be asserted during system reset. When the system finishes reset, the processor expects to read from the flash memory. Automated flash memories provide status information when read during program or Block-Erase operations. If a CPU reset occurs with no flash memory reset, proper CPU initialization cannot occur, because the flash memory might be providing status information instead of array data.

Intel<sup>®</sup> Flash memories allow proper CPU initialization after a system reset, using the RP# input. In this application, RP# is controlled by the same RESET# signal that resets the system CPU.

### 10.1.5 Write

A write occurs when both CE# and WE# are low and OE# is high. Commands are written to the Command User Interface (CUI) using standard microprocessor write timings to control flash memory operations. The CUI does not occupy an addressable memory location. The address and data buses are latched on the rising edge of the second WE# or CE# pulse, whichever occurs first.

Table 30 shows the available commands, and Appendix A provides detailed information about moving between the different modes of operation using CUI commands.

Two commands modify array data:

- Program (40H).
- Erase (20H).

Writing either of these commands to the internal Command User Interface (CUI) initiates a sequence of internally timed functions that culminate in the completion of the requested task (unless that operation is aborted by either RP# being driven to  $V_{IL}$  for  $t_{PLRH}$  or an appropriate Suspend command).

# 11.0 Operating Modes

The flash memory device has four read modes:

- read array
- read identifier
- read status
- read query

See Figure 1 "B3 Architecture Block Diagram" on page 10).

The flash memory device also has two write modes:

- program
- block erase

Three additional modes are available only during suspended operations:

- erase suspend to program
- erase suspend to read
- program suspend to read

Table 28 "Command Codes and Descriptions" on page 54 summarizes the commands used to reach these modes.

Appendix A, "Write State Machine Current/Next States," is a comprehensive chart showing the state transitions.

## 11.1 Read Array

When RP# transitions from  $V_{IL}$  (reset) to  $V_{IH}$ , the flash memory device defaults to read-array mode and responds to the read-control inputs (CE#, address inputs, and OE#) without any additional CUI commands.

When the flash memory device is in read-array mode, four control signals control data output:

- WE# must be logic high (V<sub>IH</sub>)
- CE# must be logic low (V<sub>II</sub>)
- OE# must be logic low  $(V_{IL})$
- RP# must be logic high (V<sub>IH</sub>)

In addition, the address of the preferred location must be applied to the address pins. If the flash memory device is not in read-array mode, such as after a Program or Erase operation, the Read Array command (FFH) must be written to the CUI before array reads can occur.

### Table 28. Command Codes and Descriptions (Sheet 1 of 2)

| Code                         | Device Mode                                | Description   |  |  |  |
|------------------------------|--|---|--|--|--|
| 00, 01,<br>60, 2F,<br>C0, 98 | Invalid/<br>Reserved                       | Unassigned commands that must not be used. Intel reserves the right to redefine these codes for future functions.   |  |  |  |
| FF                           | Read Array                                 | Places the flash memory device in read-array mode, so that array data is output on the data pins.   |  |  |  |
| 40                           | Program Set-Up                             | <ul> <li>A two-cycle command.</li> <li>The first cycle prepares the CUI for a program operation.</li> <li>The second cycle latches addresses and data information, and initiates the WSM to execute the program algorithm.</li> <li>The flash memory device outputs Status Register data when CE# or OE# is toggled. To read array data, a Read Array command is required after programming. See Section 11.4.</li> </ul>                               |  |  |  |
| 10                           | Alternate<br>Program Set-Up                | (See 40H/Program Set-Up)  |  |  |  |
| 20                           | Erase Set-Up                               | <ul> <li>Prepares the CUI for the Erase Confirm command. If the next command is not an Erase Confirm command, then the CUI does the following:</li> <li>1. Sets both SR.4 and SR.5 of the Status Register to 1.</li> <li>2. Places the flash memory device into the read-Status Register mode.</li> <li>3. Waits for another command.</li> <li>See Section 11.5, "Erase Mode" on page 58.</li> </ul>  |  |  |  |
| D0                           | Erase Confirm<br>Program / Erase<br>Resume | If the previous command was an Erase Set-Up command, then the CUI closes the address and data latches, and begins erasing the block indicated on the address pins.<br>During erase, the flash memory device responds only to the Read Status Register and Erase Suspend commands. The device outputs Status Register data when CE# or OE# is toggled.<br>If a Program or Erase operation was previously suspended, this command resumes that operation. |  |  |  |

| Table 28. | Command Codes and Descriptions (Sheet 2 of 2) |  |
|-----------|---|--|
|-----------|---|--|

| Code | Device Mode     | Description   |
|------|-----------------|---|
|      |                 | Issuing this command suspends the currently executing Program/Erase operation.  |
|      | Program / Erase | To indicate when the operation has been successfully suspended, the Status Register sets either the program suspend (SR.2) or erase suspend (SR.6), and sets the WSM status bit (SR.7) to 1 (ready).  |
| B0   | Suspend         | The WSM continues to idle in the SUSPEND state, regardless of the state of all input-control pins except RP#, which immediately shuts down the WSM and the remainder of the device, if it is driven to $V_{\text{IL}}$ .  |
|      |                 | See Section 11.4.1, "Suspending and Resuming Programming" on page 58 and Section 11.4.1, "Suspending and Resuming Programming" on page 58.  |
| 70   | Read Status     | This command places the flash memory device into Read-Status Register mode. Reading the device outputs the contents of the Status Register, regardless of the address presented to the device.  |
|      | Register        | The flash memory device automatically enters this mode after a Program or Erase operation is initiated. See Section 11.3, "Read Status Register" on page 56.  |
|      |                 | The WSM can set the block-lock status (SR.1), $V_{PP}$ status (SR.3), program status (SR.4), and erase status (SR.5) bits in the Status Register to 1. However, the WSM cannot clear these bits to 0. Issuing this command clears these bits to 0.  |
| 90   | Read Identifier | Places the flash memory device into the intelligent-identifier-read mode, so that reading the device outputs the manufacturer and device codes ( $A_0 = 0$ for manufacturer, $A_0 = 1$ for the device; all other address inputs must be 0). See Section 11.2, "Read Identifier" on page 56. |

Note: See Chapter 14.0, "Write State Machine Current/Next States," for mode transition information.



## 11.2 Read Identifier

To read the manufacturer and device codes, the flash memory device must be in read-identifier mode, which can be reached by writing the Read Identifier command (90H).

As shown in Table 29, once in read-identifier mode:

- $A_0 = 0$  outputs the manufacturer identification code.
- $A_0 = 1$  outputs the device identifier.

Note:

 $A_1 - A_{21} = 0.$ 

To return to read-array mode, write the Read-Array command (FFH).

### Table 29.Read Identifier Table

| Size     | Mfr. ID | Device Identifier |                  |  |  |
|----------|---------|-------------------|------------------|--|--|
| 5120     | WIT. ID | -T (Top Boot)     | -B (Bottom Boot) |  |  |
| 28F004B3 | 0089H   | D4H               | D5H              |  |  |
| 28F400B3 | 00090   | 8894H             | 8895H            |  |  |
| 28F008B3 |         | D2H               | D3H              |  |  |
| 28F800B3 | 0089H   | 8892H             | 8893H            |  |  |
| 28F016B3 |         | D0H               | D1H              |  |  |
| 28F160B3 |         | 8890H             | 8891H            |  |  |
| 28F320B3 | 0089H   | 8896H             | 8897H            |  |  |
| 28F640B3 |         | 8898H             | 8899H            |  |  |

## 11.3 Read Status Register

The flash memory device Status Register indicates when a Program or Erase operation is complete, and the success or failure of that operation.

- To read the Status Register, issue the Read Status Register (70H) command to the CUI.
  - This command causes all subsequent Read operations to output data from the Status Register until another command is written to the CUI.
- To return to reading from the array, issue the Read Array (FFH) command.

The Status Register bits are output on  $DQ_0-DQ_7$ . The upper byte,  $DQ_8-DQ_{15}$ , outputs 00H during a Read Status Register command.

The contents of the Status Register are latched on the falling edge of OE# or CE#, which prevents possible Bus errors that might occur if Status Register contents change while being read. CE# or OE# must be toggled with each subsequent status read, or the Status Register does not indicate completion of a Program or Erase operation.

When the WSM is active, SR.7 indicates the status of the WSM. The remaining bits in the Status Register indicate whether the WSM was successful in performing the preferred operation (see Table 31 on page 60).

## 11.3.1 Clearing the Status Register

The WSM sets status bits 1 through 7 to 1, and clears bits 2, 6, and 7 to 0. However, the WSM cannot clear status bits 1 or 3 through 5 to 0.

Because bits 1, 3, 4, and 5 indicate various error conditions, these bits can be cleared only through the Clear Status Register (50H) command. By allowing the system software to control the resetting of these bits, several operations can be performed (such as cumulatively programming several addresses or erasing multiple blocks in sequence) before reading the Status Register to determine if an error occurred during that series.

Clear the Status Register before beginning another command or sequence.

*Note:* The Read Array command must be issued before data can be read from the flash memory array.

# 11.4 **Program Mode**

Programming is executed using a two-write sequence.

- 1. The Program Setup command (40H) is written to the CUI.
- 2. A second write specifies the address and data to program.

The WSM executes a sequence of internally timed events to program preferred bits of the addressed location.

The WSM then verifies that the bits are sufficiently programmed.

Programming the memory changes specific bits within an address location to 0. If users attempt to program 1 instead of 0, the memory cell contents do not change and no error occurs.

The Status Register indicates the programming status: while the program sequence executes, status bit 7 is 0.

To poll the Status Register, toggle either CE# or OE#.

While programming, the only valid commands are:

- Read Status Register
- Program Suspend
- Program Resume

When programming is complete, the program-status bits must be checked.

- If the programming operation was unsuccessful, SR.4 is set, indicating a program failure.
- If SR.3 is set, then V<sub>PP</sub> was not within acceptable limits, and the WSM did not execute the program command.
- If SR.1 is set, a program operation was attempted on a locked block and the operation aborted.

Clear the Status Register before attempting the next operation. Any CUI instruction can follow after programming is completed; however, to prevent inadvertent Status Register reads, be sure to reset the CUI to read-array mode.



## 11.4.1 Suspending and Resuming Programming

The Program Suspend command halts the in-progress program operation to read data from another flash memory location.

- 1. After the programming process starts, writing the Program Suspend command to the CUI requests that the WSM suspend the program sequence (at predetermined points in the program algorithm).
- 2. The flash memory device continues to output Status Register data after the Program Suspend command is written.
- 3. Polling SR.7 and SR.2 determines when the program operation has been suspended (both are set to 1).

t<sub>WHRH1</sub>/t<sub>EHRH1</sub> specifies the program- suspend latency.

4. A Read Array command can now be written to the CUI to read data from blocks other than the suspended block.

The only other valid commands while program is suspended are:

- Read Status Register
- Read Identifier
- Program Resume
- 5. After the Program Resume command is written to the flash memory, the WSM continues with the program process, and Status Register bits SR.2 and SR.7 are automatically cleared.
- 6. After the Program Resume command is written, the flash memory device automatically outputs Status Register data when read.

See Appendix B, "Program and Erase Flowcharts."

*Note:* V<sub>PP</sub> must remain at the same V<sub>PP</sub> level used for program while in program-suspend mode. RP# must also remain at V<sub>IH</sub>.

## 11.5 Erase Mode

To erase a block:

1. Write the Erase Set-up and Erase Confirm commands to the CUI, along with an address identifying the block to be erased.

This address is latched internally when the Erase Confirm command is issued. Block erasure sets all bits within the block to 1. Only one block can be erased at a time.

- 2. The WSM executes a sequence of internally timed events :
  - a. programs all bits within the block to 0.
  - b. Erases all bits within the block to 1.

c. Verifies that all bits within the block are sufficiently erased.

While the erase executes, status bit 7 is 0.

- 3. When the Status Register indicates that erasure is complete, check the erase-status bit to verify that the Erase operation was successful.
  - If the Erase operation was unsuccessful, SR.5 of the Status Register is set to 1, indicating an erase failure.
  - If V<sub>PP</sub> was not within acceptable limits after the Erase Confirm command was issued, the WSM does not execute the erase sequence. Instead, SR.5 is set to indicate an Erase error, and SR.3 is set to 1, indicating that the V<sub>PP</sub> supply voltage was not within acceptable limits.
- 4. After an Erase operation, clear the Status Register (50H) before attempting the next operation. Any CUI instruction can follow after erasure is completed.
- 5. To prevent inadvertent status- register reads, place the flash memory device in read-array mode after the erase is complete.

## 11.5.1 Suspending and Resuming Erase

Because an Erase operation requires on the order of seconds to complete, an Erase Suspend command is provided. Erase Suspend interrupts an erase sequence to read data from—or program data to— another block in memory.

After the erase sequence is started, writing the Erase Suspend command to the CUI requests that the WSM pauses the erase sequence at a predetermined point in the erase algorithm.

Note:

The Status Register will indicates if/when the Erase operation has been suspended.

- A Read Array/Program command can now be written to the CUI, to read data from/ program data to blocks other than the one currently suspended.
- The Program command can subsequently be suspended to read yet another array location.

The only valid commands while Erase is suspended are:

- Erase Resume
- Program
- Read Array
- Read Status Register
- Read Identifier

During erase-suspend mode, to place the flash memory device in a pseudo-standby mode, set CE# to  $V_{IH}$ , which reduces active current consumption.

Erase Resume continues the erase sequence when  $CE\# = V_{IL}$ . As with the end of a standard Erase operation, the Status Register must be read and cleared before the next instruction is issued.

#### Command Bus Definitions <sup>(1,4)</sup> Table 30.

|                       |       | Fi    | First Bus Cycle |              | Second Bus Cycle |      | ycle |
|-----------------------|-------|-------|-----------------|--------------|------------------|------|------|
| Command               | Notes | Oper  | Addr            | Data         | Oper             | Addr | Data |
| Read Array            |       | Write | Х               | FFH          |                  |      |      |
| Read Identifier       | 2     | Write | Х               | 90H          | Read             | IA   | ID   |
| Read Status Register  |       | Write | Х               | 70H          | Read             | Х    | SRD  |
| Clear Status Register |       | Write | Х               | 50H          |                  |      |      |
| Program               | 3     | Write | х               | 40H /<br>10H | Write            | PA   | PD   |
| Block Erase/Confirm   |       | Write | Х               | 20H          | Write            | BA   | D0H  |
| Program/Erase Suspend |       | Write | Х               | B0H          |                  |      |      |
| Program/Erase Resume  |       | Write | Х               | D0H          |                  |      |      |

#### Notes:

3. 4. PA: Program Address PD: Program Data IA: Identifier Address ID: Identifier Data

BA: Block Address

SRD: Status Register Data

1. Bus operations are defined in Table 27.

2. Following the Intelligent Identifier command, two Read operations access manufacturer and device codes.

 $-A_0 = 0$  for manufacturer code.  $-A_0 = 1$  for device code.  $-A_1 - A_{21} = 0.$ 

Either the 40H or 10H command is valid. The standard is 40H. When writing commands to the flash memory device, the upper data bus  $[DQ_8-DQ_{15}]$  must be either V<sub>IL</sub> or V<sub>IH</sub>, to minimize current draw.

#### Table 31. **Status Register Bit Definition**

| WSMS | ESS | ES | PS | VPPS | PSS | BLS | R |
|------|-----|----|----|------|-----|-----|---|
| 7    | 6   | 5  | 4  | 3    | 2   | 1   | 0 |

| Bits  | NOTES:  |
|---|---|
| SR.7 = WRITE STATE MACHINE STATUS (WSMS)<br>1 = Ready<br>0 = Busy                           | Check Write State Machine bit first to determine word program<br>or block-erase completion, before checking program or erase-<br>status bits.                   |
| SR.6 = ERASE-SUSPEND STATUS (ESS)<br>1 = Erase Suspended<br>0 = Erase In Progress/Completed | When erase suspend is issued, WSM halts execution and sets<br>both WSMS and ESS bits to 1. ESS bit remains set at 1 until an<br>Erase Resume command is issued. |
| SR.5 = ERASE STATUS (ES)<br>1 = Error In Block Erasure<br>0 = Successful Block Erase        | When this bit is set to 1, WSM has applied the maximum number of erase pulses to the block and is still unable to verify successful block erasure.              |
| SR.4 = PROGRAM STATUS (PS)<br>1 = Error in Word Program<br>0 = Successful Word Program      | When this bit is set to 1, WSM has attempted but failed to program a word.  |

| Bits   | NOTES:  |
|--|---|
| SR.3 = $V_{PP}$ STATUS (VPPS)<br>1 = $V_{PP}$ Low Detect, Operation Abort<br>0 = $V_{PP}$ OK                                       | The V <sub>PP</sub> status bit does not continuously indicate the V <sub>PP</sub> level.<br>The WSM interrogates the V <sub>PP</sub> level only after the Program or<br>Erase command sequences are entered, and informs the<br>system if V <sub>PP</sub> has not been switched on. The V <sub>PP</sub> is also<br>checked before the WSM verifies the operation. The V <sub>PP</sub> status<br>bit is not guaranteed to report accurate feedback between<br>V <sub>PPLK</sub> max and V <sub>PP1</sub> min or between V <sub>PP1</sub> max and V <sub>PP4</sub> min. |
| SR.2 = PROGRAM SUSPEND STATUS (PSS)<br>1 = Program Suspended<br>0 = Program in Progress/Completed                                  | When program suspend is issued, WSM halts execution and sets both WSMS and PSS bits to 1. The PSS bit remains set to 1 until a Program Resume command is issued.  |
| SR.1 = BLOCK LOCK STATUS<br>1 = Program/Erase attempted on locked block;<br>Operation aborted<br>0 = No operation to locked blocks | If a Program or Erase operation is attempted to one of the<br>locked blocks, the WSM sets this bit. The operation specified is<br>aborted and the flash memory device returns to read status<br>mode.   |
| SR.0 = RESERVED FOR FUTURE ENHANCEMENTS (R)  | This bit is reserved for future use and must be masked out when polling the Status Register.  |

Note: A Command Sequence Error is indicated when SR.4, SR.5, and SR.7 are set.



# **12.0 Block Locking**

The B3 flash memory device architecture features two hardware-lockable parameter blocks.

## 12.1 WP# = V<sub>IL</sub> for Block Locking

The lockable blocks are locked when  $WP\# = V_{IL}$ ; any program or Erase operation to a locked block results in an error, which is reflected in the Status Register:

- For top configuration, the top two parameter blocks are lockable:
  - blocks #133 and #134 for 64 Mbit
  - blocks #69 and #70 for 32 Mbit
  - blocks #37 and #38 for 16 Mbit
  - blocks #21 and #22 for 8 Mbit
  - blocks #13 and #14 for 4 Mbit
- For the bottom configuration, the bottom two parameter blocks are lockable. These are blocks #0 and #1 for 4, 8, 16, 32, and 64 Mbit.

Unlocked blocks can be programmed or erased normally (unless V<sub>PP</sub> is below V<sub>PPLK</sub>).

## 12.2 WP# = V<sub>IH</sub> for Block Unlocking

WP# =  $V_{IH}$  unlocks all lockable blocks. These blocks can now be programmed or erased.

- *Note:* RP# does not override WP# locking for the B3 flash memory device, as in previous Boot Block devices.
  - WP# controls all block locking.
  - V<sub>PP</sub> provides protection against spurious writes.

Table 32 defines the write- protection methods.

### Table 32. Write-Protection Truth Table for the B3 Device Family

| V <sub>PP</sub> | WP#             | RP#             | Write Protection Provided |
|-----------------|-----------------|-----------------|---------------------------|
| Х               | Х               | V <sub>IL</sub> | All Blocks Locked         |
| VIL             | Х               | V <sub>IH</sub> | All Blocks Locked         |
| $\geq V_{PPLK}$ | V <sub>IL</sub> | $V_{IH}$        | Lockable Blocks Locked    |
| $\geq V_{PPLK}$ | V <sub>IH</sub> | V <sub>IH</sub> | All Blocks Unlocked       |

#### **VPP** Program and Erase Voltages 13.0

TheB3 flash memory device products provide in-system programming and erase at 2.7 V. For customers requiring fast programming in their manufacturing environment, the B3 flash memory device includes an additional low-cost 12-V programming feature.

The 12-V V<sub>PP</sub> mode enhances programming performance during the short period of time typically found in manufacturing processes. However, this mode is not intended for extended use. 12 V can be applied to  $V_{PP}$  during program and Erase operations for a maximum of 1000 cycles on the main blocks, and 2500 cycles on the parameter blocks.  $V_{PP}$  can be connected to 12 V for a total of 80 hours maximum.

Warning: Stressing the flash memory device beyond these limits might cause permanent damage.

> During Read operations or idle times, V<sub>PP</sub> can be tied to a 5-V supply. For Program and Erase operations, a 5-V supply is not permitted. The  $V_{PP}$  must be supplied with either 2.7 V to 3.6 V or 11.4 V to 12.6 V during Program and Erase operations.

#### V<sub>PP</sub> = V<sub>IL</sub> for Complete Protection 13.1

The  $V_{PP}$  programming voltage can be held low for complete write protection of all blocks in the flash memory device. When  $V_{PP}$  is below  $V_{PPLK}$ , any Program or Erase operation results in an error, prompting the corresponding SR.3 to be set.

#### **Additional Information** 14.0

| Order Number                      | Document/Tool   |
|-----------------------------------|---|
| 297948                            | Intel <sup>®</sup> Advanced Boot Block Flash Memory Family Specification Update |
| 292199                            | AP-641 Achieving Low Power with the 3 Volt Advanced Boot Block Flash Memory     |
| 292200                            | AP-642 Designing for Upgrade to the 3 Volt Advanced Boot Block Flash Memory     |
| Note 2                            | 3 Volt Advanced Boot Block Algorithms ('C' and assembly)                        |
|                                   | http://developer.intel.com/design/flash/swtools                                 |
| Contact your Intel Representative | Intel <sup>®</sup> Flash Data Integrator (IFDI) Software Developer's Kit        |
| 297874                            | IFDI Interactive: Play with Intel <sup>®</sup> Flash Data Integrator on Your PC |

Notes:

Call the Intel Literature Center at (800) 548-4725 to request Intel documentation. International customers must contact 1. their local Intel or distribution sales office. 2.

Visit the Intel home page at http://www.Intel.com or http://developer.intel.com for technical documentation and tools.

For the most current information about Intel® Advanced Boot Block Flash memory and Intel® Advanced+ Boot Block 3. Flash memory, visit http://developer.intel.com/design/flash/

# Appendix A Write State Machine Current/Next States

|   |      |                      | Command Input (and Next State)        |   |                         |   |                                    |                                       |   |   |                              |
|---|------|----------------------|---------------------------------------|---|-------------------------|---|------------------------------------|---------------------------------------|---|---|------------------------------|
| Current<br>State                        | SR.7 | Data<br>When<br>Read | Read<br>Array<br>(FFH)                | Program<br>Setup<br>(10/40H)  | Erase<br>Setup<br>(20H) | Erase<br>Confirm<br>(D0H)                               | Prog/Ers<br>Suspend<br>(B0H)       | Prog/Ers<br>Resume<br>(D0H)           | Read<br>Status<br>(70H)                 | Clear<br>Status<br>(50H)                | Read<br>Identifier.<br>(90H) |
| Read Array                              | "1"  | Array                | Read<br>Array                         | Program<br>Setup  | Erase<br>Setup          | Read Array  |                                    | Read<br>Status                        | Read<br>Array                           | Read<br>Identifier                      |                              |
| Read<br>Status                          | "1"  | Status               | Read<br>Array                         | Program<br>Setup  | Erase<br>Setup          | Read Array  |                                    |                                       | Read<br>Status                          | Read<br>Array                           | Read<br>Identifier           |
| Read<br>Identifier                      | "1"  | Identifier           | Read<br>Array                         | Program<br>Setup  | Erase<br>Setup          | Read Array  |                                    |                                       | Read<br>Status                          | Read<br>Array                           | Read<br>Identifier           |
| Prog. Setup                             | "1"  | Status               |                                       |   | Progra                  | m (Comman   | d Input = Da                       | ta to be Prog                         | grammed)                                |   |                              |
| Program<br>(continue)                   | "0"  | Status               |                                       | Program (continue)<br>Program (continue)<br>Rd.<br>Status                               |                         |   | Program (continue)                 |                                       |   |   |                              |
| Program<br>Suspend to<br>Read<br>Status | "1"  | Status               | Prog.<br>Susp.<br>to<br>Read<br>Array | usp.<br>to<br>to Read Array Program<br>(continue<br>) Program<br>(continue<br>) Array ) |                         | Program<br>(continue<br>)                               | Prog.<br>Susp.to<br>Read<br>Status | Prog.<br>Susp.<br>to<br>Read<br>Array | Prog.<br>Susp. to<br>Read<br>Identifier |   |                              |
| Program<br>Suspend to<br>Read Array     | "1"  | Array                | Prog.<br>Susp.<br>to<br>Read<br>Array | Program Suspend<br>to Read Array  |                         | Program<br>Susp. to<br>Read<br>Array                    | Program<br>(continue<br>)          | Prog.<br>Susp.to<br>Read<br>Status    | Prog.<br>Sus.to<br>Read<br>Array        | Prog.<br>Susp. to<br>Read<br>Identifier |                              |
| Prog. Susp.<br>to Read<br>Identifier    | "1"  | ldentifier           | Prog.<br>Susp.<br>to<br>Read<br>Array | Program Suspend<br>to Read Array<br>)   |                         | Program<br>Susp. to<br>Read<br>Array                    | Program<br>(continue<br>)          | Prog.<br>Susp.to<br>Read<br>Status    | Prog.<br>Sus.to<br>Read<br>Array        | Prog.<br>Susp. to<br>Read<br>Identifier |                              |
| Program<br>(complete)                   | "1"  | Status               | Read<br>Array                         | Program<br>Setup  | Erase<br>Setup          | Read Array  |                                    | Read<br>Status                        | Read<br>Array                           | Read<br>Identifier                      |                              |
| Erase<br>Setup                          | "1"  | Status               | Erase                                 | e Command   | Error                   | Erase<br>(continue<br>) Error Erase<br>(continue<br>) ) |                                    |                                       | Erase Command Error                     |   |                              |
| Erase Cant.<br>Error                    | "1"  | Status               | Read<br>Array                         | Program<br>Setup  | Erase<br>Setup          | Read Array  |                                    | Read<br>Status                        | Read<br>Array                           | Read<br>Identifier                      |                              |
| Erase<br>(continue)                     | "0"  | Status               | Erase (continue)                      |   |                         | Erase<br>Sus. to<br>Read<br>Status                      |                                    | Erase (continue)                      |   |   |                              |

## Table 33.Write State Machine (Sheet 1 of 2)

intel

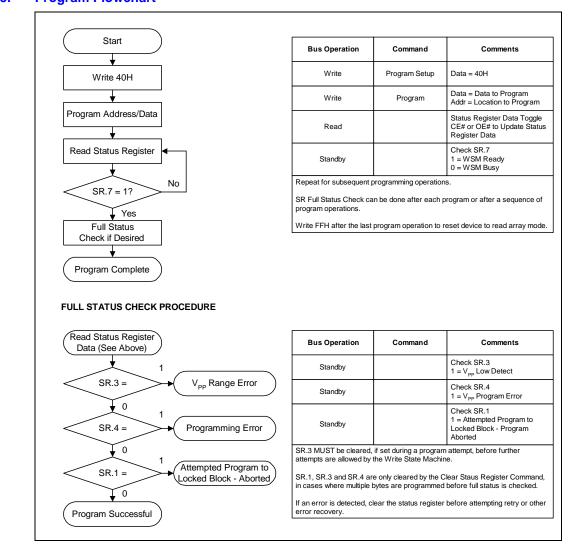


|   |      |                      | Command Input (and Next State)        |                              |                                       |                           |                                    |                             |                                    |                                       |  |
|---|------|----------------------|---------------------------------------|------------------------------|---------------------------------------|---------------------------|------------------------------------|-----------------------------|------------------------------------|---------------------------------------|--|
| Current<br>State                        | SR.7 | Data<br>When<br>Read | Read<br>Array<br>(FFH)                | Program<br>Setup<br>(10/40H) | Erase<br>Setup<br>(20H)               | Erase<br>Confirm<br>(D0H) | Prog/Ers<br>Suspend<br>(B0H)       | Prog/Ers<br>Resume<br>(D0H) | Read<br>Status<br>(70H)            | Clear<br>Status<br>(50H)              | Read<br>Identifier.<br>(90H)           |
| Erase<br>Suspend to<br>Status           | "1"  | Status               | Erase<br>Susp.<br>to<br>Read<br>Array | Program<br>Setup             | Erase<br>Susp.<br>to<br>Read<br>Array | Erase                     | Erase<br>Susp. to<br>Read<br>Array | Erase                       | Erase<br>Susp.to<br>Read<br>Status | Erase<br>Susp.<br>to<br>Read<br>Array | Ers.<br>Susp. to<br>Read<br>Identifier |
| Erase<br>Susp. to<br>Read Array         | "1"  | Array                | Erase<br>Susp.<br>to<br>Read<br>Array | Program<br>Setup             | Erase<br>Susp.<br>to<br>Read<br>Array | Erase                     | Erase<br>Susp. to<br>Read<br>Array | Erase                       | Erase<br>Susp.to<br>Read<br>Status | Erase<br>Susp.<br>to<br>Read<br>Array | Ers.<br>Susp. to<br>Read<br>Identifier |
| Erase<br>Susp. to<br>Read<br>Identifier | "1"  | Identifier           | Erase<br>Susp.<br>to<br>Read<br>Array | Program<br>Setup             | Erase<br>Susp.<br>to<br>Read<br>Array | Erase                     | Erase<br>Susp. to<br>Read<br>Array | Erase                       | Erase<br>Susp.to<br>Read<br>Status | Erase<br>Susp.<br>to<br>Read<br>Array | Ers.<br>Susp. to<br>Read<br>Identifier |
| Erase<br>(complete)                     | "1"  | Status               | Read<br>Array                         | Program<br>Setup             | Erase<br>Setup                        | Read Array                |                                    | Read<br>Status              | Read<br>Array                      | Read<br>Identifier                    |  |

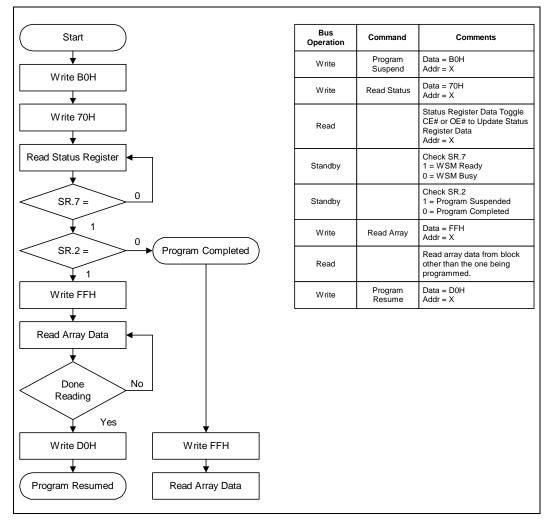
## Table 33.Write State Machine (Sheet 2 of 2)



# **Appendix B Program and Erase Flowcharts**

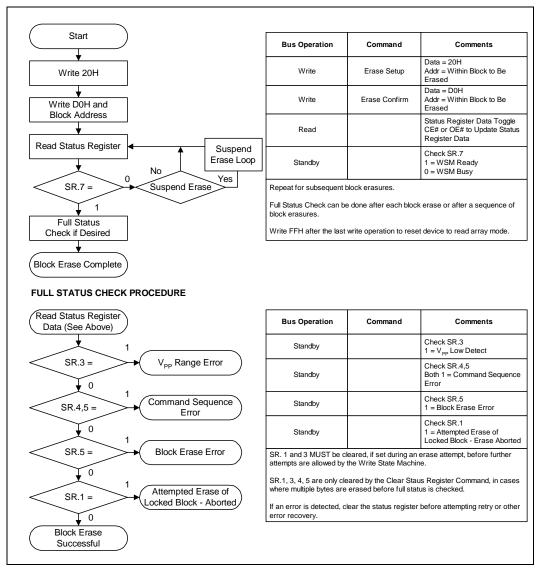


### Figure 16. Program Suspend/Resume Flowchart

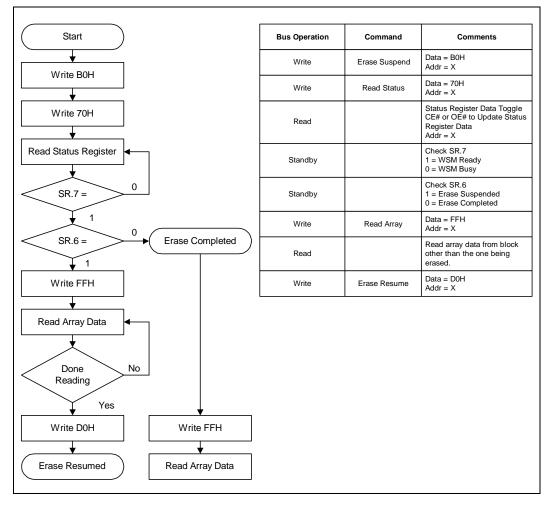




### Figure 17. Block Erase Flowchart



### Figure 18. Erase Suspend/Resume Flowchart



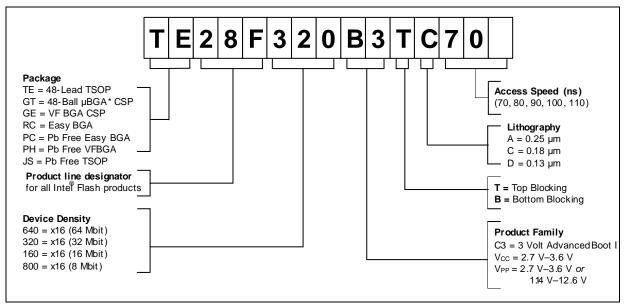
Datasheet

Downloaded from Arrow.com.



# **Appendix C Ordering Information**

### Figure 19. Ordering Information



## Table 34. Ordering Information: Valid Combinations (Sheet 1 of 2)

|                    | 40-Lead TSOP | 48-Lead TSOP  | 48-Ball µBGA CSP <sup>(1,2)</sup> | 48-Ball VF BGA   |
|--------------------|--------------|---|-----------------------------------|--|
| Ext. Temp. 64 Mbit |              | TE28F640B3TC80<br>TE28F640B3BC80  |                                   | GE28F640B3TC80<br>GE28F640B3BC80   |
| Ext. Temp. 32 Mbit |              | TE28F320B3TD70<br>TE28F320B3BD70<br>TE28F320B3BC70<br>TE28F320B3BC70<br>TE28F320B3TC90<br>TE28F320B3TC90<br>TE28F320B3BC90<br>TE28F320B3BA100<br>TE28F320B3BA100<br>TE28F320B3BA110<br>JS28F320B3TD70<br>JS28F320B3BD70 |                                   | GE28F320B3TD70<br>GE28F320B3BD70<br>GE28F320B3TC70<br>GE28F320B3BC70<br>GE28F320B3TC90<br>GE28F320B3BC90<br>PH28F320B3BD70 |

# Int

| Table 34.Ordering Information: | Valid Combinations (Sheet 2 of 2) |
|--------------------------------|-----------------------------------|
|--------------------------------|-----------------------------------|

|                    | 40-Lead TSOP   | 48-Lead TSOP   | 48-Ball µBGA CSP <sup>(1,2)</sup>  | 48-Ball VF BGA   |
|--------------------|--|--|--|--|
| Ext. Temp. 16 Mbit | TE28F016B3TA90<br>TE28F016B3BA90<br>TE28F016B3TA110<br>TE28F016B3BA110 | TE28F160B3TD70<br>TE28F160B3BD70<br>TE28F160B3BC70<br>TE28F160B3BC70<br>TE28F160B3BC80<br>TE28F160B3BC90<br>TE28F160B3TC90<br>TE28F160B3TA90<br>TE28F160B3BA90<br>TE28F160B3BA90<br>TE28F160B3BA110<br>JS28F160B3BA170<br>JS28F160B3BD70 | GT28F160B3TA90 <sup>(3)</sup><br>GT28F160B3BA90 <sup>(3)</sup><br>GT28F160B3TA110 <sup>(3)</sup><br>GT28F160B3BA110 <sup>(3)</sup> | GE28F160B3TD70<br>GE28F160B3BD70<br>GE28F160B3TC70<br>GE28F160B3BC70<br>GE28F160B3TC80<br>GE28F160B3BC80<br>GE28F160B3TC90<br>GE28F160B3BC90<br>PH28F160B3TD70<br>PH28F160B3BD70 |
| Ext. Temp. 8 Mbit  |  | TE28F800B3TA90<br>TE28F800B3BA90   |  | GE28F800B3TA70<br>GE28F800B3BA70   |
|                    |  | TE28F800B3BA110<br>TE28F800B3BA110   |  | GE28F800B3TA90<br>GE28F800B3BA90   |

Notes:

2.

The second line of the 48-ball µBGA package top side mark specifies assembly codes. For samples only, the first character signifies either:

E for engineering samples, or
 S for silicon daisy-chain samples.

All other assembly codes without an E or an S as the first character are production units.

3. Intel recommends using 18 µm Intel® Advanced Boot Block Products.

The 48-ball µBGA package top side mark reads F160B3. This mark is identical for both x8 and x16 products. All 1. product shipping boxes or trays provide the correct information regarding bus architecture. However, once the flash memory devices are removed from the shipping media, differentiating based on the top side mark might be difficult. The device identifier (accessible through the Device ID command: see Section 11.2, "Read Identifier" on page 56 for further details) enables x8 and x16 µBGA package product differentiation.